Dual Channel 12-Bit 500 Msps Analog to Digital Converter

Check for Samples: ADS5407

FEATURES

- **Dual Channel**
- **12-Bit Resolution**
- **Maximum Clock Rate: 500 Msps**
- **Low Swing Fullscale Input: 1.25 Vpp**
- **Analog Input Buffer with High Impedance Input**
- **Input Bandwidth (3dB): >1.0 GHz**
- **Data Output Interface: DDR LVDS**
- **Optional 2x Decimation with Low Pass or High Pass Filter**
- **196-Pin BGA Package (12 x 12mm)**

APPLICATIONS

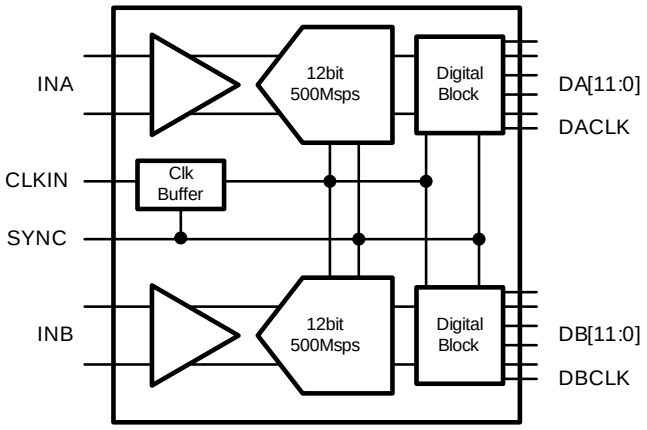
- **Test and Measurement Instrumentation**
- **Ultra-Wide Band Software Defined Radio**
- **Data Acquisition**
- **Power Amplifier Linearization**
- **Signal Intelligence and Jamming**
- **Radar and Satellite Systems**
- **Microwave Receivers**

KEY SPECIFCATIONS

- **Power Dissipation: 675 mW/ch (Auto Correction Disabled)**
- **Spectral Performance at f_{IN} = 230 MHz IF**
  - **SNR: 63.7 dBFS**
  - **SFDR:**
    - **77 dBc (Auto Correction Disabled off)**
    - **75 dBc (Auto Correction Disabled on)**
- **Spectral Performance at f_{IN} = 450 MHz IF**
  - **SNR: 63.6 dBFS**
  - **SFDR:**
    - **77 dBc (Auto Correction Disabled off)**
    - **75 dBc (Auto Correction Disabled on)**

DESCRIPTION

The ADS5407 is a high linearity dual channel 12-bit, 500 MSPS analog-to-digital converter (ADC) easing front end filter design for wide bandwidth receivers. The analog input buffer isolates the internal switching of the on-chip track-and-hold from disturbing the signal source as well as providing a high-impedance input. Optionally the output data can be decimated by two. Designed for high SFDR, the ADC has low-noise performance and outstanding spurious-free dynamic range over a large input-frequency range. The device is available in a 196 pin BGA package and is specified over the full industrial temperature range (–40°C to 85°C).



Device Part No.	Number of Channels	Speed Grade
ADS5402	2	800 Msps
ADS5401	1	800 Msps
ADS5404	2	500 Msps
ADS5403	1	500 Msps
ADS5407	2	500 Msps
ADS5409	2	900 Msps

This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

DETAILED BLOCK DIAGRAM

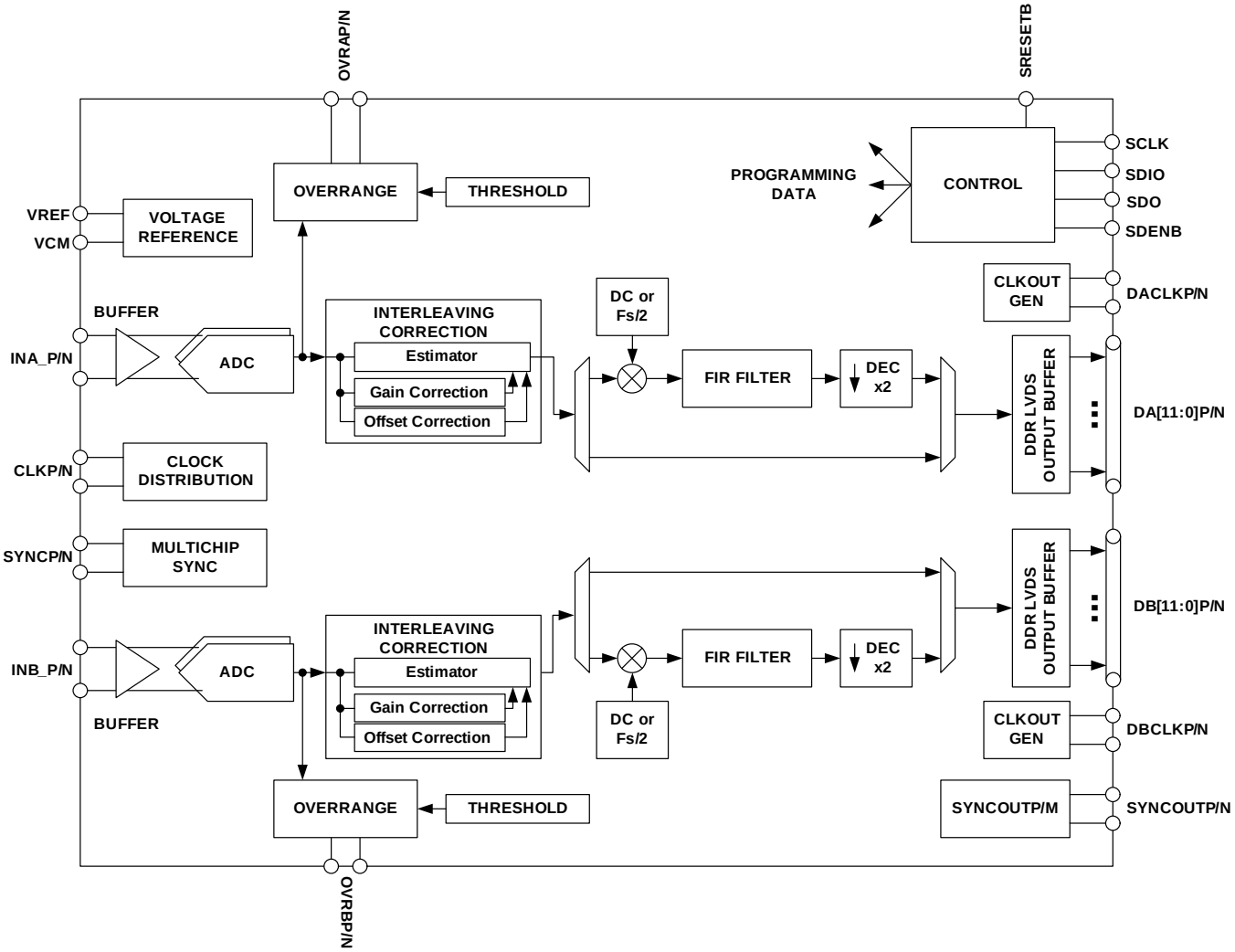


Figure 1. Detailed Block Diagram

PINOUT INFORMATION

	A	B	C	D	E	F	G	H	J	K	L	M	N	P	
14	VREF	VCM	GND	INB_N	INB_P	GND	AVDDC	AVDDC	GND	INA_P	INA_N	GND	GND	CLKINP	14
13	SDENB	TEST MODE	GND	GND	GND	GND	GND	GND	GND	GND	GND	GND	GND	CLKINN	13
12	SCLK	SRESET B	GND	AVDD33	AVDD33	AVDD33	AVDD33	AVDD33	AVDD33	AVDD33	AVDD33	GND	AVDD33	AVDD33	12
11	SDIO	ENABLE	GND	AVDD18	AVDD18	AVDD18	AVDD18	AVDD18	AVDD18	AVDD18	AVDD18	GND	AVDD18	AVDD18	11
10	SDO	IOVDD	GND	AVDD18	GND	GND	GND	GND	GND	GND	AVDD18	GND	NC	NC	10
9	DVDD	DVDD	GND	GND	GND	GND	GND	GND	GND	GND	GND	GND	SYNCN	SYNCP	9
8	DVDD	DVDD	DVDD	DVDD	GND	GND	GND	GND	GND	GND	DVDD	DVDD	DVDD	DVDD	8
7	DB0N	DB0P	DVDD LVDS	DVDD LVDS	GND	GND	GND	GND	GND	GND	DVDD LVDS	DVDD LVDS	NC	NC	7
6	DB1N	DB1P	DVDD LVDS	DVDD LVDS	GND	GND	GND	GND	GND	GND	DVDD LVDS	DVDD LVDS	NC	NC	6
5	DB2N	DB2P	OVRBN	OVRBP	GND	GND	GND	GND	GND	GND	OVRAN	OVRAP	SYNC OUTN	SYNC OUTP	5
4	DB3N	DB3P	DB8P	DB10P	NC	NC	NC	DA0P	DA2P	DA4P	DA6P	DA8P	NC	NC	4
3	DB4N	DB4P	DB8N	DB10N	NC	NC	NC	DA0N	DA2N	DA4N	DA6N	DA8N	DA11N	DA11P	3
2	DB5N	DB5P	DB7P	DB9P	DB11P	SYNC OUTP	DBCLKP	DACLKP	DA1P	DA3P	DA5P	DA7P	DA10N	DA10P	2
1	DB6N	DB6P	DB7N	DB9N	DB11N	SYNC OUTN	DBCLKN	DACLKN	DA1N	DA3N	DA5N	DA7N	DA9N	DA9P	1
	A	B	C	D	E	F	G	H	J	K	L	M	N	P	

Figure 2. Pinout in DDR output mode (top down view)

PIN ASSIGNMENTS

PIN		I/O	DESCRIPTION
NAME	**NUMBER**		
INPUT/REFERENCE			
INA_P/N	K14, L14	I	Analog ADC A differential input signal.
INB_P/N	E14, D14	I	Analog ADC B differential input signal.
VCM	B14	O	Output of the analog input common mode (nominally 1.9V). A 0.1µF capacitor to AGND is recommended.
VREF	A14	O	Reference voltage output (2V nominal). A 0.1µF capacitor to AGND is recommended, but not required.
CLOCK/SYNC			
CLKINP/N	P14, P13	I	Differential input clock
SYNCP/N	P9, N9	I	Synchronization input. Inactive if logic low. When clocked in a high state initially, this is used for resetting internal clocks and digital logic and starting the SYNCOUT signal. Internal 100Ω termination.
CONTROL/SERIAL			

PIN ASSIGNMENTS (continued)

PIN		I/O	DESCRIPTION
NAME	NUMBER		
SRESET	B12	I	Serial interface reset input. Active low. Initialized internal registers during high to low transition. Asynchronous. Internal 50kΩ pull up resistor to IOVDD.
ENABLE	B11	I	Chip enable – active high. Power down function can be controlled through SPI register assignment. Internal 50kΩ pull up resistor to IOVDD.
SCLK	A12	I	Serial interface clock. Internal 50kΩ pull-down resistor.
SDIO	A11	I/O	Bi-directional serial data in 3 pin mode (default). In 4-pin interface mode (register x00, D16), the SDIO pin is an input only. Internal 50kΩ pull-down.
SDENB	A13	I	Serial interface enable. Internal 50kΩ pull-down resistor.
SDO	A10	O	Uni-directional serial interface data in 4 pin mode (register x00, D16). The SDO pin is tri-stated in 3-pin interface mode (default). Internal 50kΩ pull-down resistor.
TESTMODE	B13	–	Factory internal test, do not connect
DATA INTERFACE			
DA[11:0]P/N	P3, N3, P2, N2, P1, N1, M4, M3, M2, M1, L4, L3, L2, L1, K4, K3, K2, K1, J4, J3, J2, J1, H4, H3	O	ADC A Data Bits 11 (MSB) to 0 (LSB) in DDR output mode. Standard LVDS output.
DB[11:0]P/N	E2, E1, D4, D3, D2, D1, C4, C3, C2, C1, B1, A1, B2, A2, B3, A3, B4, A4, B5, A5, B6, A6, B7, A7	O	ADC B Data Bits 11 (MSB) to 0 (LSB) in DDR output mode. Standard LVDS output.
DACLKP/N	H2, H1	O	DDR differential output data clock for Bus A. Register programmable to provide either rising or falling edge to center of stable data nominal timing.
DBCLKP/N	G2, G1	O	DDR differential output data clock for Bus B. Register programmable to provide either rising or falling edge to center of stable data nominal timing. Optionally Bus B can be latched with DACLKP/N.
SYNCOUTP/N	F2, F1, P5, N5	O	Synchronization output signal for synchronizing multiple ADCs. Can be disabled via SPI.
OVRAP/N	M5, L5	O	Bus A, Overrange indicator, LVDS output. A logic high signals an analog input in excess of the full-scale range. Optional SYNC output.
OVRBP/N	D5, C5	O	Bus B, Overrange indicator, LVDS output. A logic high signals an analog input in excess of the full-scale range. Optional SYNC output.
NC	E3, E4, F3, F4, G3, G4, N4, N6, N7, N10, P4, P6, P7, P10	–	Don't connect to pin
POWER SUPPLY			
AVDD33	D12, E12, F12, G12, H12, J12, K12, L12, N12, P12	I	3.3V analog supply
AVDDC	G14, H14	I	1.8V supply for clock input
AVDD18	D10, D11, E11, F11, G11, H11, J11, K11, L10, L11, N11, P11	I	1.8V analog supply
DVDD	A8, A9, B8, B9, C8, D8, L8, M8, N8, P8	I	1.8V supply for digital block
DVDDLVDS	C6, C7, D6, D7, L6, L7, M6, M7	I	1.8V supply for LVDS outputs
IOVDD	B10	I	1.8V for digital I/Os
GND		I	Ground

PACKAGE/ORDERING INFORMATION

PRODUCT	PACKAGE- LEAD	PACKAGE DESIGNATOR	SPECIFIED TEMPERATURE RANGE	PACKAGE MARKING	ORDERING NUMBER	TRANSPORT MEDIA, QUANTITY
ADS5407	196-BGA	ZAY	–40C to 85C	ADS5407I	ADS5407IZAY	Tray
					ADS5407IZAYR	Tape and Reel

ABSOLUTE MAXIMUM RATINGS

over operating free-air temperature range (unless otherwise noted)

		VALUE		UNIT
		MIN	MAX	
Supply voltage range, AVDD33		–0.5	4	V
Supply voltage range, AVDDC		–0.5	2.3	V
Supply voltage range, AVDD18		–0.5	2.3	V
Supply voltage range, DVDD		–0.5	2.3	V
Supply voltage range, DVDDLVDS		–0.5	2.3	V
Supply voltage range, IOVDD		–0.5	4	V
Voltage applied to input pins	INA/B_P, INA/B_N	–0.5	AVDD33 + 0.5	V
	CLKINP, CLKINN	–0.5	AVDDC + 0.5	V
	SYNCP, SYNCN	–0.5	AVDD33 + 0.5	V
	SRESET, SDENB, SCLK, SDIO, SDO, ENABLE	–0.5	IOVDD + 0.5	V
Operating free-air temperature range, T_A		–40	85	°C
Operating junction temperature range, T_J			150	°C
Storage temperature range		–65	150	°C
ESD, Human Body Model			2	kV

THERMAL INFORMATION

THERMAL METRIC(1)		ADS5407 nFBGA (196-PIN)	UNITS
θ_{JA}	Junction-to-ambient thermal resistance	37.6	°C/W
θ_{JCtop}	Junction-to-case (top) thermal resistance	6.8	
θ_{JB}	Junction-to-board thermal resistance	16.8	
ψ_{JT}	Junction-to-top characterization parameter	0.2	
ψ_{JB}	Junction-to-board characterization parameter	16.4	

(1) For more information about traditional and new thermal metrics, see the *IC Package Thermal Metrics* application report, SPRA953.

RECOMMENDED OPERATING CONDITIONS

over operating free-air temperature range (unless otherwise noted)

		MIN	NOM	MAX	UNIT
T_J	Recommended operating junction temperature			105	°C
	Maximum rated operating junction temperature(1)	125			
T_A	Recommended free-air temperature	–40	25	85	°C

(1) Prolonged use at this junction temperature may increase the device failure-in-time (FIT) rate.

ELECTRICAL CHARACTERISTICS

Typical values at T_A = 25°C, full temperature range is T_{MIN} = –40°C to T_{MAX} = 85°C, ADC sampling rate = 500Msps, 50% clock duty cycle, AVDD33 = 3.3V, AVDDC/AVDD18/DVDD/DVDDLVDS/IOVDD = 1.8V, –1dBFS differential input (unless otherwise noted).

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNITS
ADC Clock Frequency		40		500	MSPS
Resolution		12			Bits
SUPPLY					
AVDD33		3.15	3.3	3.45	V
AVDDC, AVDD18, DVDD, DVDDLVDS		1.7	1.8	1.9	V
IOVDD		1.7	1.8	3.45	V
POWER SUPPLY					
I_{AVDD33} 3.3V Analog supply current			239	270	mA
I_{AVDD18} 1.8V Analog supply current			79	90	mA
I_{AVDDC} 1.8V Clock supply current			27	35	mA
I_{DVDD} 1.8V Digital supply current	Auto Correction Disabled		117	140	mA
I_{DVDD} 1.8V Digital supply current	Auto Correction Enabled		207		mA
I_{DVDD} 1.8V Digital supply current	Auto Correction Disabled, decimation filter enabled		142		mA
$I_{DVDDLVDS}$ 1.8V LVDS supply current	Unused LVDS outputs Disabled		104	120	mA
I_{IOVDD} 1.8V I/O Voltage supply current			1	2	mA
P_{dis} Total power dissipation	Auto Correction Disabled, decimation filter disabled		1.35	1.5	W
PSRR	250kHz to 500MHz	40			dB
Shut-down power dissipation			7		mW
Shut-down wake up time			2.5		ms
Standby power dissipation			7		mW
Standby wake up time			100		µs
Deep-sleep mode power dissipation	Auto correction disabled		264		mW
	Auto correction enabled		371		mW
Deep-sleep mode wakeup time			20		µs
Light-sleep mode power dissipation	Auto correction disabled		559		mW
	Auto correction enabled		666		mW
Light-sleep mode wakeup time			2		µs

ELECTRICAL CHARACTERISTICS

Typical values at T_A = 25°C, full temperature range is T_{MIN} = –40°C to T_{MAX} = 85°C, ADC sampling rate = 500Msps, 50% clock duty cycle, AVDD3V = 3.3V, AVDD/DRVDD/IOVDD = 1.8V, –1dBFS differential input (unless otherwise noted).

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNITS
ANALOG INPUTS					
Differential input full-scale			1.0	1.25	Vpp
Input common mode voltage			1.9	±0.1	V
Input resistance	Differential at DC		1		kΩ
Input capacitance	Each input to GND		2		pF
VCM common mode voltage output			1.9		V
Analog input bandwidth (3dB)			1000		MHz
DYNAMIC ACCURACY					
Offset Error	Auto Correction Disabled	–20	±4	20	mV
	Auto Correction Enabled	–1	0	1	mV
Offset temperature coefficient			–611		µV/°C
Gain error		–5	±0.6	5	%FS
Gain temperature coefficient			0.005		%FS/°C
Differential nonlinearity	f_{IN} = 230 MHz	–1	±0.8	2	LSB
Integral nonlinearity	f_{IN} = 230 MHz	–5	±2	5	LSB
CLOCK INPUT					
Input clock frequency		40		500	MHz
Input clock amplitude			2		Vpp
Input clock duty cycle		40%	50%	60%	
Internal clock biasing			0.9		V

ELECTRICAL CHARACTERISTICS

Typical values at T_A = 25°C, full temperature range is T_{MIN} = –40°C to T_{MAX} = 85°C, ADC sampling rate = 500Msps, 50% clock duty cycle, AVDD33 = 3.3V, AVDDC/AVDD18/DVDD/DVDDLVDS/IOVDD = 1.8V, –1dBFS differential input (unless otherwise noted).

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	MIN	TYP	MAX	UNITS
Auto Correction				Enabled			Disabled		Vpp
DYNAMIC AC CHARACTERISTICS(1) – Vref = 1.25V									
SNR	Signal to Noise Ratio	f_{IN} = 10 MHz		63.6			63.8		dBFS
		f_{IN} = 100 MHz		63.5			63.7		
		f_{IN} = 230 MHz		63.5		61.5	63.7		
		f_{IN} = 450 MHz		63.1			63.6		
		f_{IN} = 700 MHz		62.5			63.2		
HD2,3	Second and third harmonic distortion	f_{IN} = 10 MHz		84			81		dBc
		f_{IN} = 100 MHz		84			83		
		f_{IN} = 230 MHz		76		55	77		
		f_{IN} = 450 MHz		82			84		
		f_{IN} = 700 MHz		74			74		
Non HD2,3	Spur Free Dynamic Range (excluding second, third harmonic distortion and Fs/2-Fin spur)	f_{IN} = 10 MHz		78			79		dBc
		f_{IN} = 100 MHz		78			79		
		f_{IN} = 230 MHz		76		70	77		
		f_{IN} = 450 MHz		76			77		
		f_{IN} = 700 MHz		72			72		
IL	Fs/2-Fin interleaving spur	f_{IN} = 10 MHz		90			87		dBc
		f_{IN} = 100 MHz		86			85		
		f_{IN} = 230 MHz		83		60	80		
		f_{IN} = 450 MHz		81			80		
		f_{IN} = 700 MHz		77			77		
SINAD	Signal to noise and distortion ratio	f_{IN} = 10 MHz		63.4			63.6		dBFS
		f_{IN} = 100 MHz		63.3			63.5		
		f_{IN} = 230 MHz		63.1		55	63.4		
		f_{IN} = 450 MHz		62.8			63.0		
		f_{IN} = 700 MHz		61.8			62.4		
THD	Total Harmonic Distortion	f_{IN} = 10 MHz		77			77		dBc
		f_{IN} = 100 MHz		76			77		
		f_{IN} = 230 MHz		74		54	74		
		f_{IN} = 450 MHz		75			75		
		f_{IN} = 700 MHz		70			70		
IMD3	Inter modulation distortion	f_{IN} = 129.5 and 130.5MHz, -7dBFS		83			83		dBFS
		f_{IN} = 349.5 and 350.5MHz, -7dBFS		80			78		
	Crosstalk			90			90		dB
ENOB	Effective number of bits	f_{IN} = 230 MHz		10.2			10.3		Bit

(1) SNR calculations do not include the DC, Fs/2 and Fs/2-fin bins when Auto correction is disabled.

ELECTRICAL CHARACTERISTICS

Typical values at T_A = 25°C, full temperature range is T_{MIN} = –40°C to T_{MAX} = 85°C, ADC sampling rate = 500Msps, 50% clock duty cycle, AVDD33 = 3.3V, AVDDC/AVDD18/DVDD/DVDDLVDS/IOVDD = 1.8V, –1dBFS differential input (unless otherwise noted).

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNITS
OVER-DRIVE RECOVERY ERROR						
	Input overload recovery	Recovery to within 5% (of final value) for 6dB overload with sine wave input		2		ns
SAMPLE TIMING CHARACTERISTICS						
rms	Aperture Jitter	Sample uncertainty		100		fs rms
	Data Latency	ADC sample to digital output, auto correction disabled		38		Clock Cycles
		ADC sample to digital output, auto correction enabled		50		
		ADC sample to digital output, Decimation filter enabled, Auto correction disabled		74		Sampling clock Cycles
	Over-range Latency	ADC sample to over-range output		12		Clock Cycles

ELECTRICAL CHARACTERISTICS

The DC specifications refer to the condition where the digital outputs are not switching, but are permanently at a valid logic level 0 or 1. AVDD33 = 3.3V, AVDDC/AVDD18/DVDD/DVDDLVDS/IOVDD = 1.8V

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNITS
DIGITAL INPUTS – SRESET, SCLK, SDENB, SDIO, ENABLE						
	High-level input voltage	All digital inputs support 1.8V and 3.3V logic levels.	0.7 x IOVDD			V
	Low-level input voltage				0.3 x IOVDD	V
	High-level input current		–50		200	µA
	Low-level input current		–50		50	µA
	Input capacitance			5		pF
DIGITAL OUTPUTS – SDO						
	High-level output voltage	I_{Load} = -100uA	IOVDD – 0.2			V
		I_{Load} = -2mA	0.8 x IOVDD			
	Low-level output voltage	I_{Load} = 100uA			0.2	V
		I_{Load} = 2mA			0.22 x IOVDD	
DIGITAL INPUTS – SYNCP/N, TRIGGERP/N						
V_{ID}	Differential input voltage		250	350	450	mV
V_{CM}	Input common mode voltage		1.125	1.2	1.375	V
t_{SU}			500			ps
DIGITAL OUTPUTS – DA[11:0]P/N, DACLKP/N, OVRAP/N, SYNCOUTP/N, TRDYP/N, HRESP/N, DB[11:0]P/N, DBCLKP/N, OVRBP/N,						
V_{OD}	Output differential voltage	I_{OUT} = 3.5mA	250	350	450	mV
V_{OCM}	Output common mode voltage	I_{OUT} = 3.5mA	1.125	1.25	1.375	V
t_{suA}	F_S = 500Msps	Data valid to zero-crossing of DACLK	600	800		ps
t_{hA}	F_S = 500Msps	Zero-crossing of DACLK to data becoming invalid	600	790		ps
t_{suB}	F_S = 500Msps	Data valid to zero-crossing of DBCLK	700	900		ps
t_{hB}	F_S = 500Msps	Zero-crossing of DBCLK to data becoming invalid	500	600		ps
t_{PD}	F_S = 500Msps	CLKIN falling edge to DACLK, DBCLK rising edge	3.28	3.48	3.74	ns

ELECTRICAL CHARACTERISTICS (continued)

The DC specifications refer to the condition where the digital outputs are not switching, but are permanently at a valid logic level 0 or 1. AVDD33 = 3.3V, AVDDC/AVDD18/DVDD/DVDDLVDS/IOVDD = 1.8V

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNITS
t_{RISE}	10% - 90%	100	150	200	ps
t_{FALL}	90% - 10%	100	150	200	ps

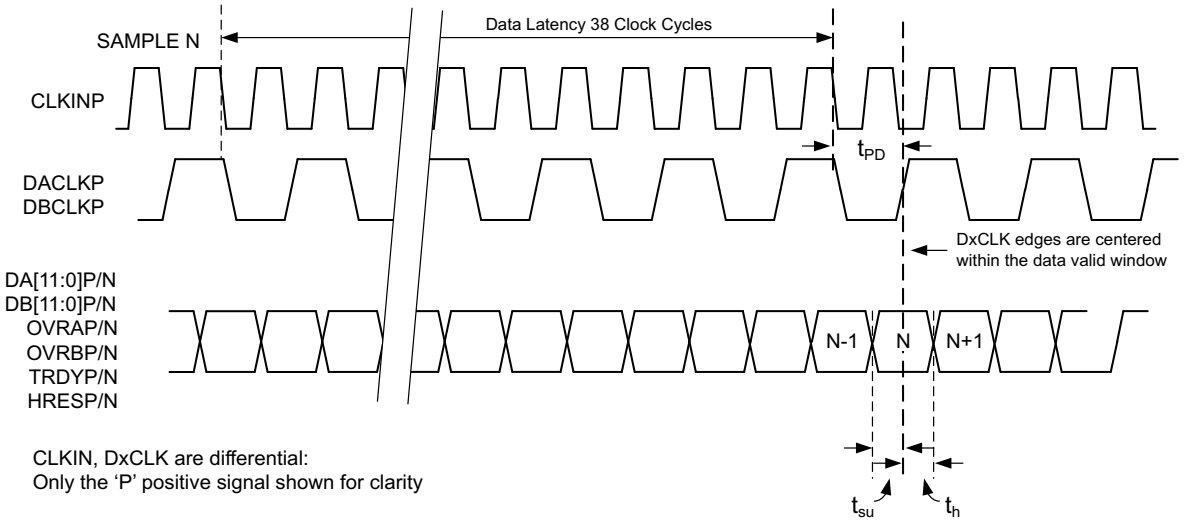


Figure 3. Timing Diagram for 12-bit DDR Output

TYPICAL CHARACTERISTICS

Typical values at TA = +25°C, full temperature range is T_{MIN} = -40°C to T_{MAX} = +85°C, ADC sampling rate = 500Msps, 50% clock duty cycle, AVDD33 = 3.3V, AVDDC/AVDD18/DVDD/DVDDLVDS/IOVDD = 1.8V, Vref = 1.25V, -1dBFS differential input, unless otherwise noted.

FFT FOR 10 MHz INPUT SIGNAL (auto on)

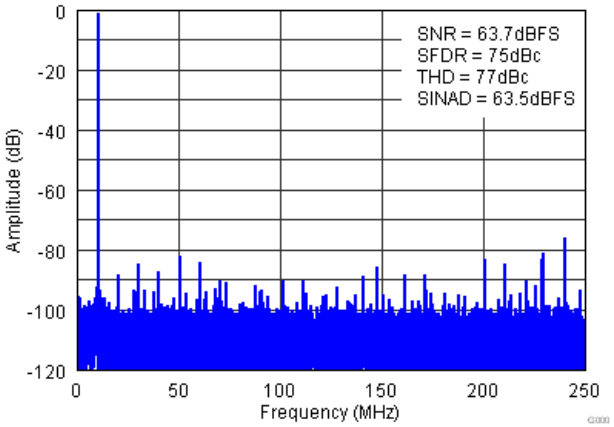


Figure 4.

FFT FOR 10 MHz INPUT SIGNAL (auto off)

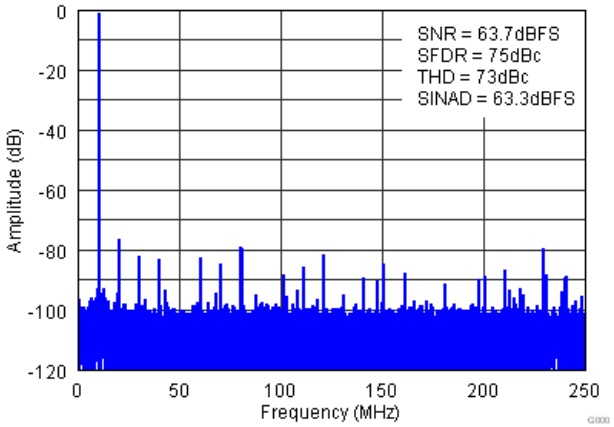


Figure 5.

FFT FOR 230 MHz INPUT SIGNAL (auto on)

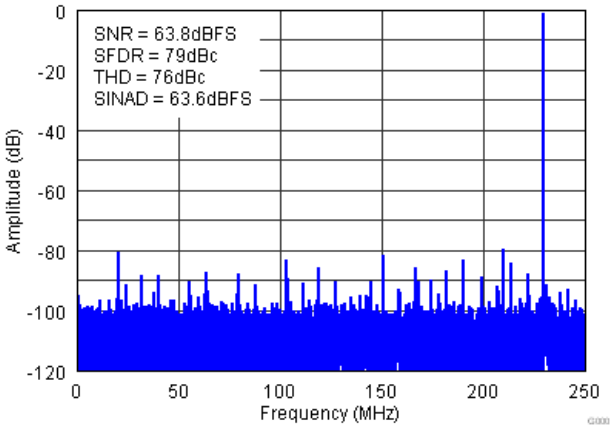


Figure 6.

FFT FOR 230 MHz INPUT SIGNAL (auto off)

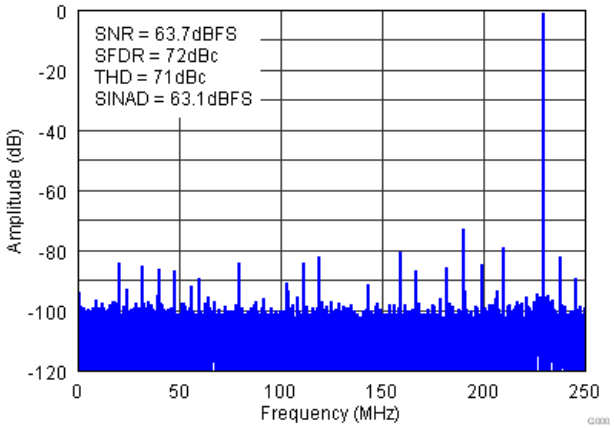


Figure 7.

FFT FOR 450 MHz INPUT SIGNAL (auto on)

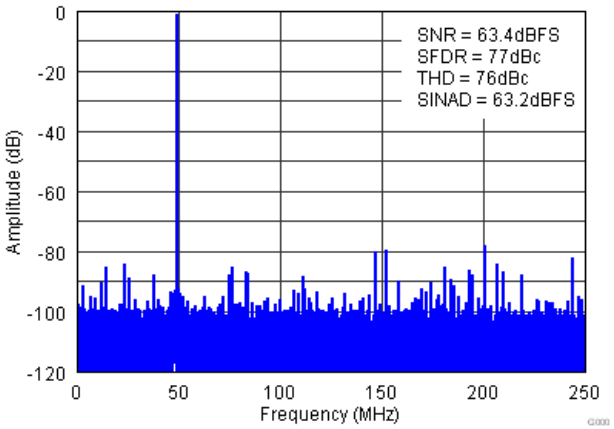


Figure 8.

FFT FOR 450 MHz INPUT SIGNAL (auto off)

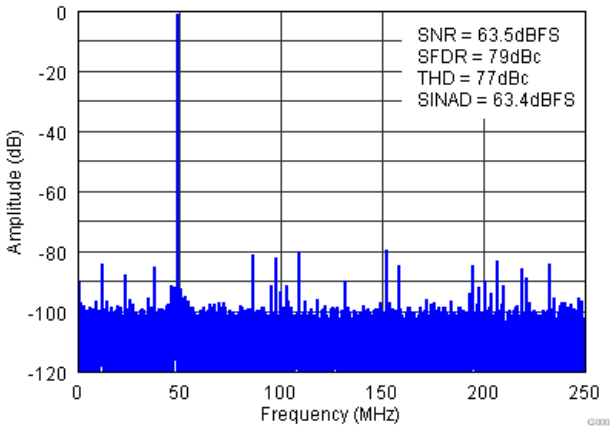


Figure 9.

TYPICAL CHARACTERISTICS (continued)

Typical values at TA = +25°C, full temperature range is T_{MIN} = -40°C to T_{MAX} = +85°C, ADC sampling rate = 500Msps, 50% clock duty cycle, AVDD33 = 3.3V, AVDDC/AVDD18/DVDD/DVDDLVDS/IOVDD = 1.8V, Vref = 1.25V, -1dBFS differential input, unless otherwise noted.

FFT FOR 700 MHz INPUT SIGNAL (auto on)

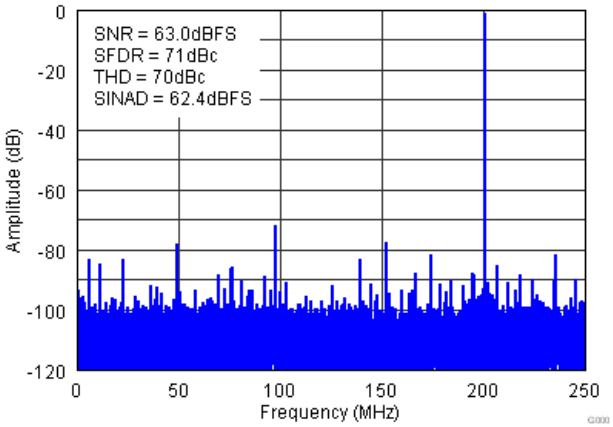


Figure 10.

FFT FOR 700 MHz INPUT SIGNAL (auto off)

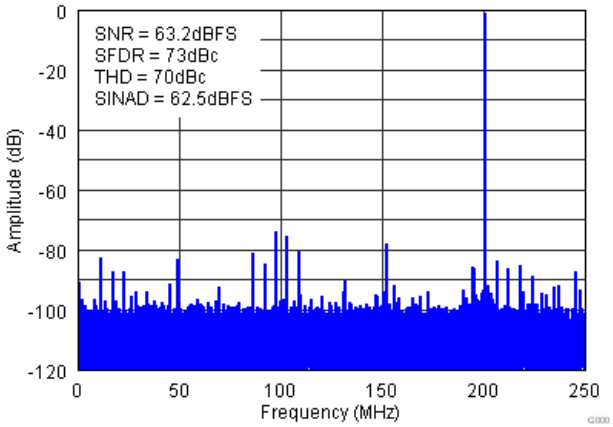


Figure 11.

FFT FOR tWO TONE INPUT SIGNAL (auto on)

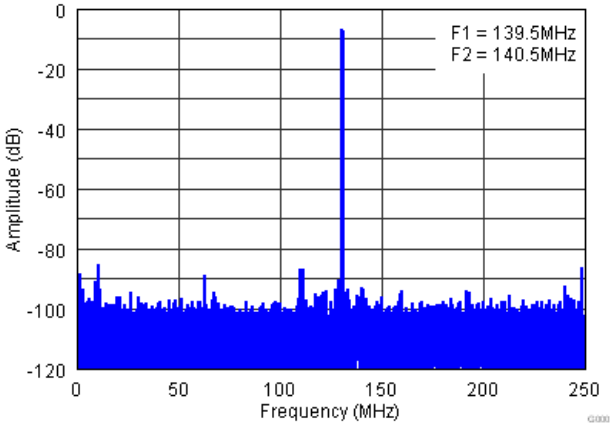


Figure 12.

FFT FOR tWO TONE INPUT SIGNAL (auto off)

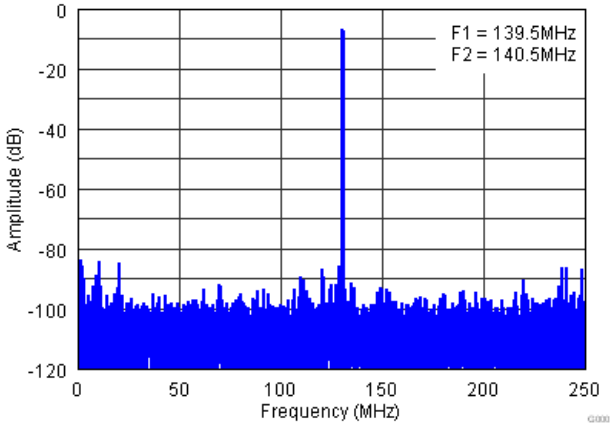


Figure 13.

SFDR vs INPUT FREQUENCY

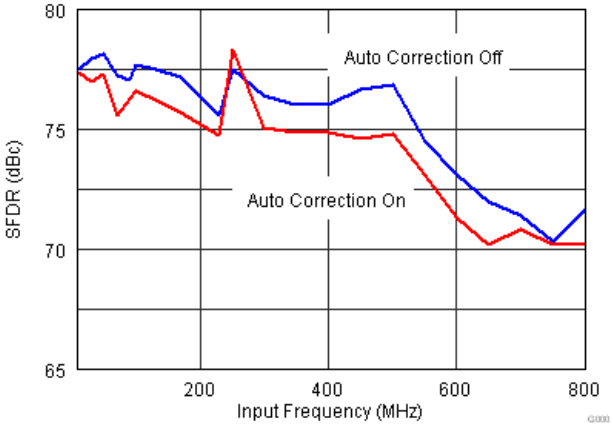


Figure 14.

SNR vs INPUT FREQUENCY

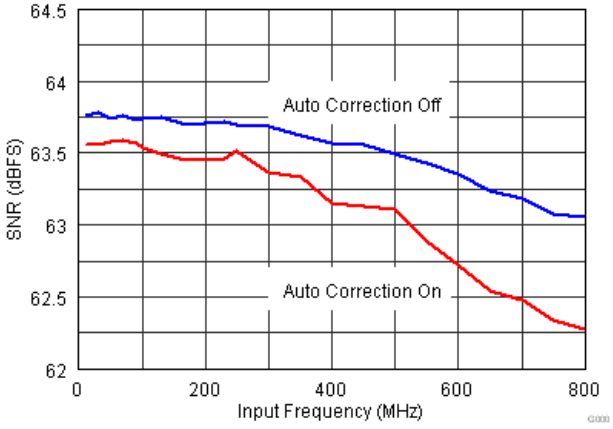


Figure 15.

TYPICAL CHARACTERISTICS (continued)

Typical values at TA = +25°C, full temperature range is T_{MIN} = -40°C to T_{MAX} = +85°C, ADC sampling rate = 500Msps, 50% clock duty cycle, AVDD33 = 3.3V, AVDDC/AVDD18/DVDD/DVDDLVDS/IOVDD = 1.8V, Vref = 1.25V, -1dBFS differential input, unless otherwise noted.

SFDR vs AMPLITUDE (fin = 230MHz)

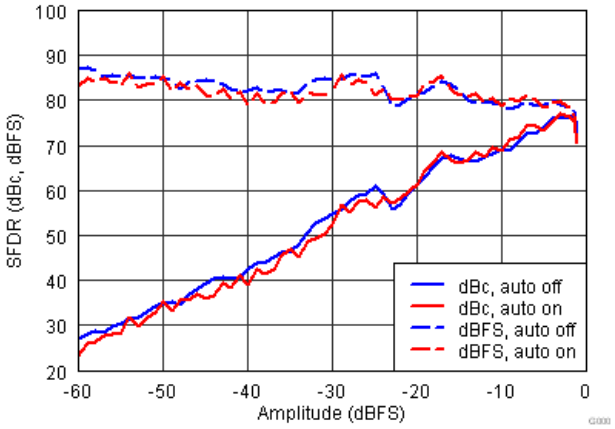


Figure 16.

SNR vs Amplitude (fin = 230 MHz)

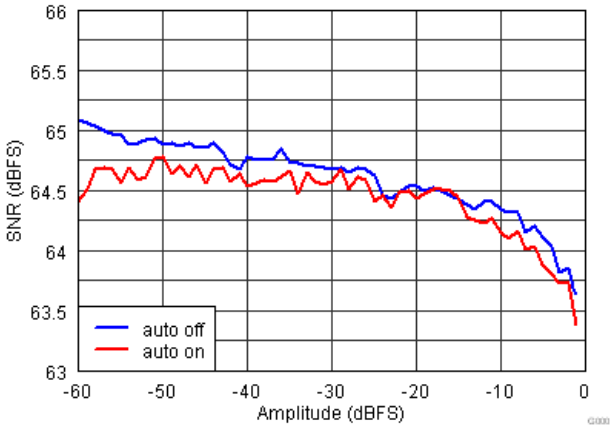


Figure 17.

Tow Tone Performance Across Input Amplitude (fin = 130MHz)

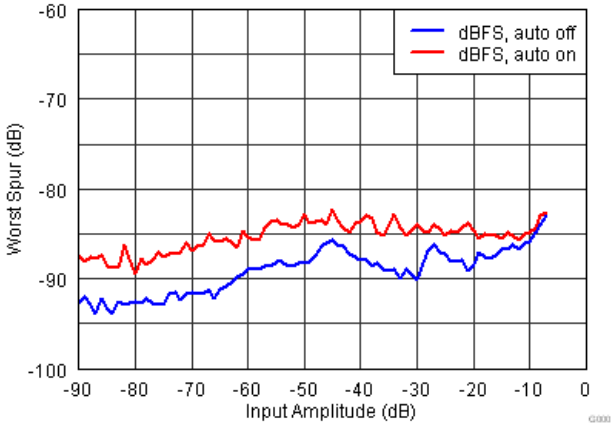


Figure 18.

SFDR vs Vref (auto on)

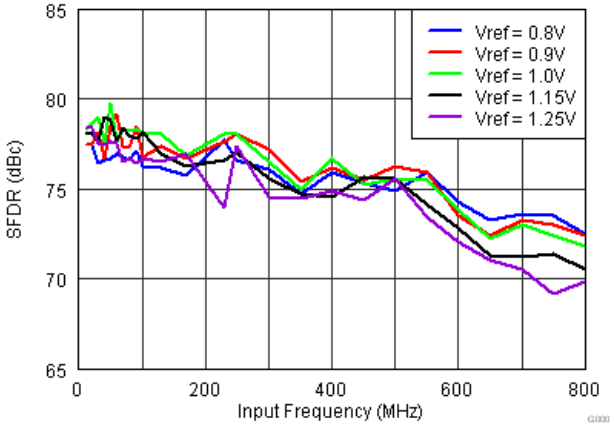


Figure 19.

TYPICAL CHARACTERISTICS (continued)

Typical values at TA = +25°C, full temperature range is T_{MIN} = -40°C to T_{MAX} = +85°C, ADC sampling rate = 500Msps, 50% clock duty cycle, AVDD33 = 3.3V, AVDDC/AVDD18/DVDD/DVDDLVDS/IOVDD = 1.8V, Vref = 1.25V, -1dBFS differential input, unless otherwise noted.

SFDR vs Vref (auto off)

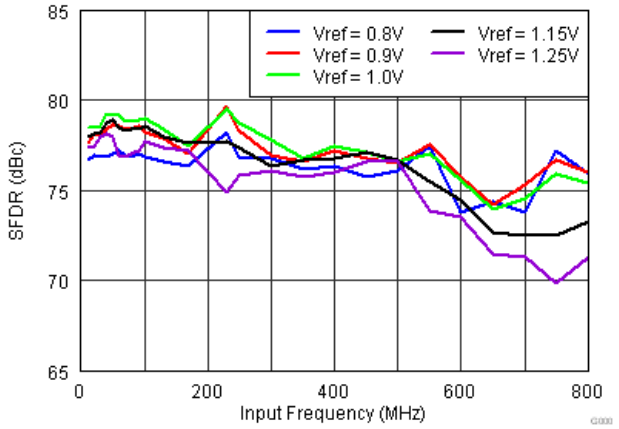


Figure 20.

SNR vs Vref (auto on)

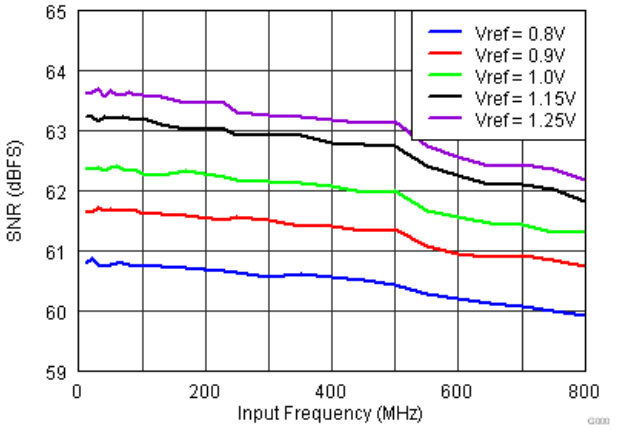


Figure 21.

SNR vs Vref (auto off)

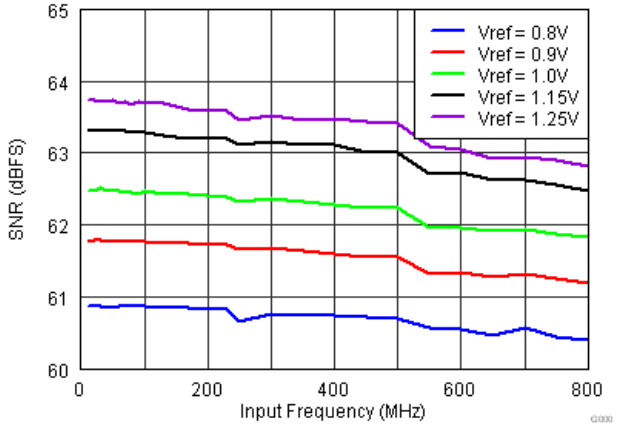


Figure 22.

Performance Across Input Common Mode Voltage

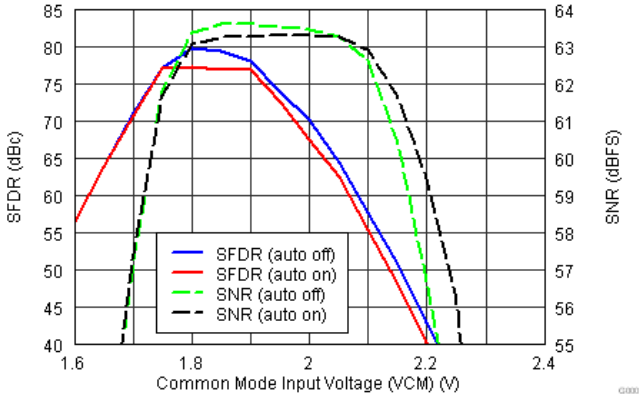


Figure 23.

Performance Across Temperature (fin = 230MHz)

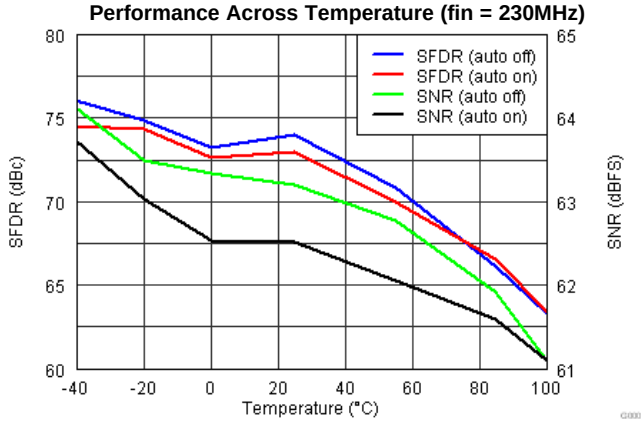


Figure 24.

Performance Across AVDD33 (fin = 230MHz)

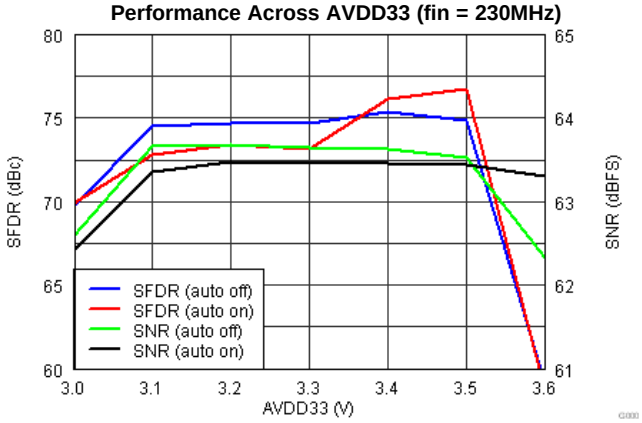


Figure 25.

TYPICAL CHARACTERISTICS (continued)

Typical values at TA = +25°C, full temperature range is T_{MIN} = -40°C to T_{MAX} = +85°C, ADC sampling rate = 500Msps, 50% clock duty cycle, AVDD33 = 3.3V, AVDDC/AVDD18/DVDD/DVDDLVDS/IOVDD = 1.8V, Vref = 1.25V, -1dBFS differential input, unless otherwise noted.

Performance Across AVDD18 (fin = 230MHz)

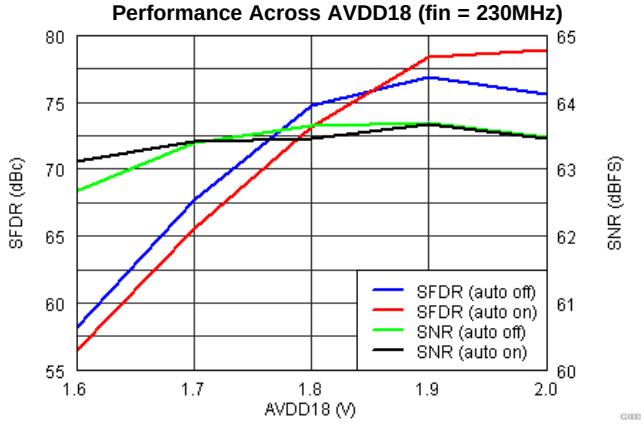


Figure 26.

Performance Across Clock Amplitude

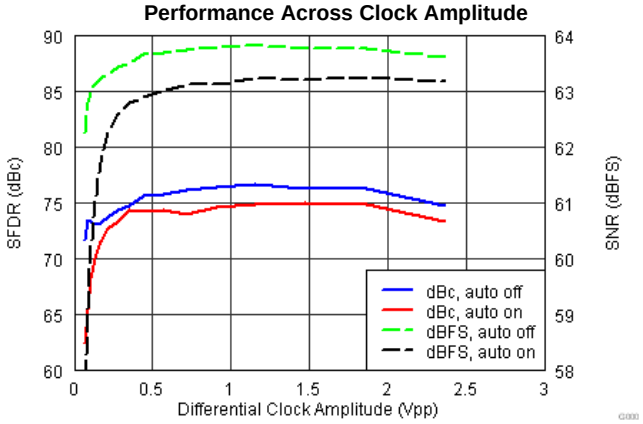


Figure 27.

INL

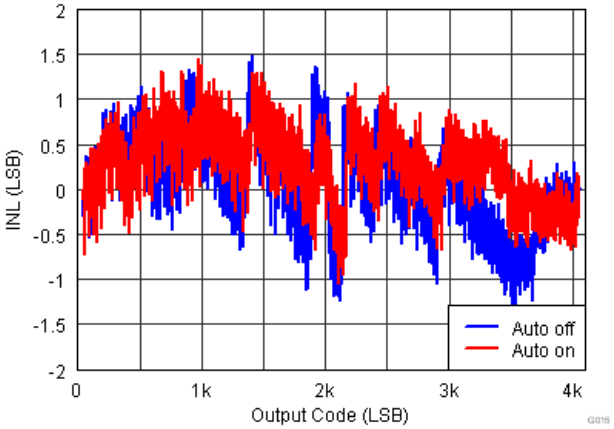


Figure 28.

DNL

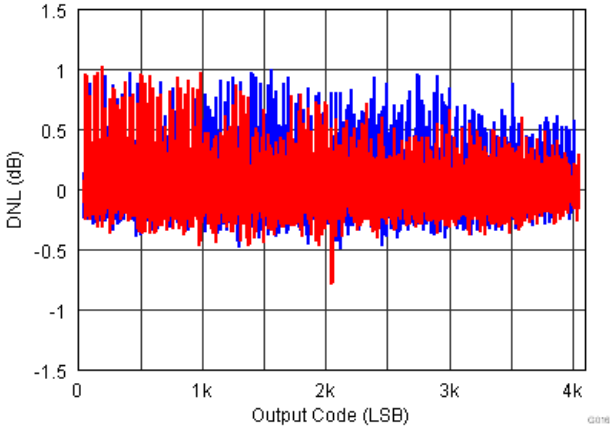


Figure 29.

CMRR Across Frequency

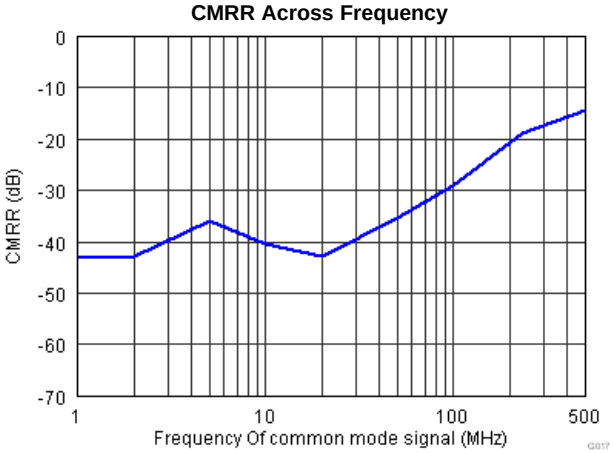


Figure 30.

PSRR Across Frequency

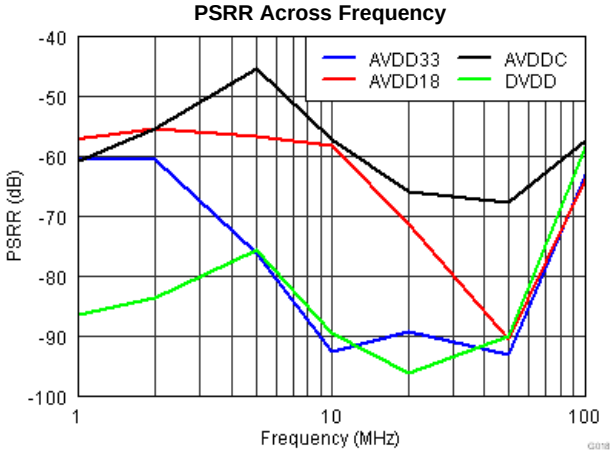


Figure 31.

TYPICAL CHARACTERISTICS (continued)

Typical values at TA = +25°C, full temperature range is T_{MIN} = -40°C to T_{MAX} = +85°C, ADC sampling rate = 500Msps, 50% clock duty cycle, AVDD33 = 3.3V, AVDDC/AVDD18/DVDD/DVDDLVDS/IOVDD = 1.8V, Vref = 1.25V, -1dBFS differential input, unless otherwise noted.

Power Across Sampling Frequency

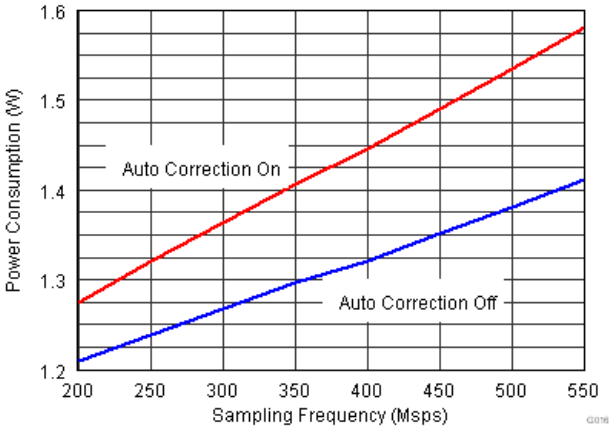


Figure 32.

SFDR Across Input and Sampling Frequencies (auto on)

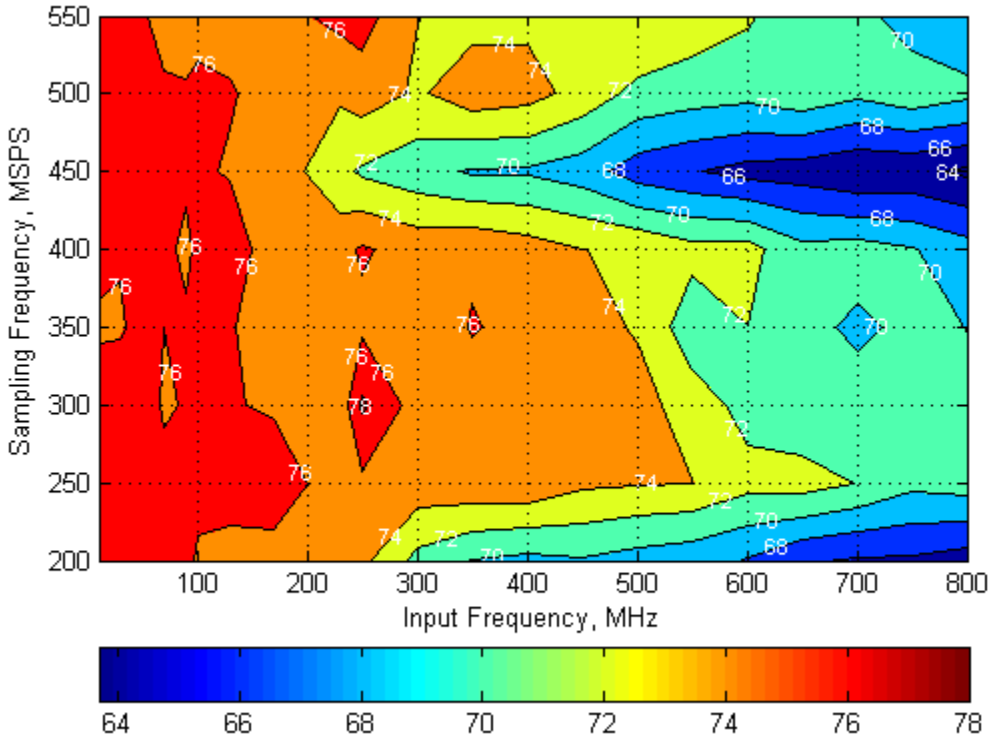


Figure 33.

TYPICAL CHARACTERISTICS (continued)

Typical values at TA = +25°C, full temperature range is T_{MIN} = -40°C to T_{MAX} = +85°C, ADC sampling rate = 500Msps, 50% clock duty cycle, AVDD33 = 3.3V, AVDDC/AVDD18/DVDD/DVDDLVDS/IOVDD = 1.8V, Vref = 1.25V, -1dBFS differential input, unless otherwise noted.

SFDR Across Input and Sampling Frequencies (auto off)

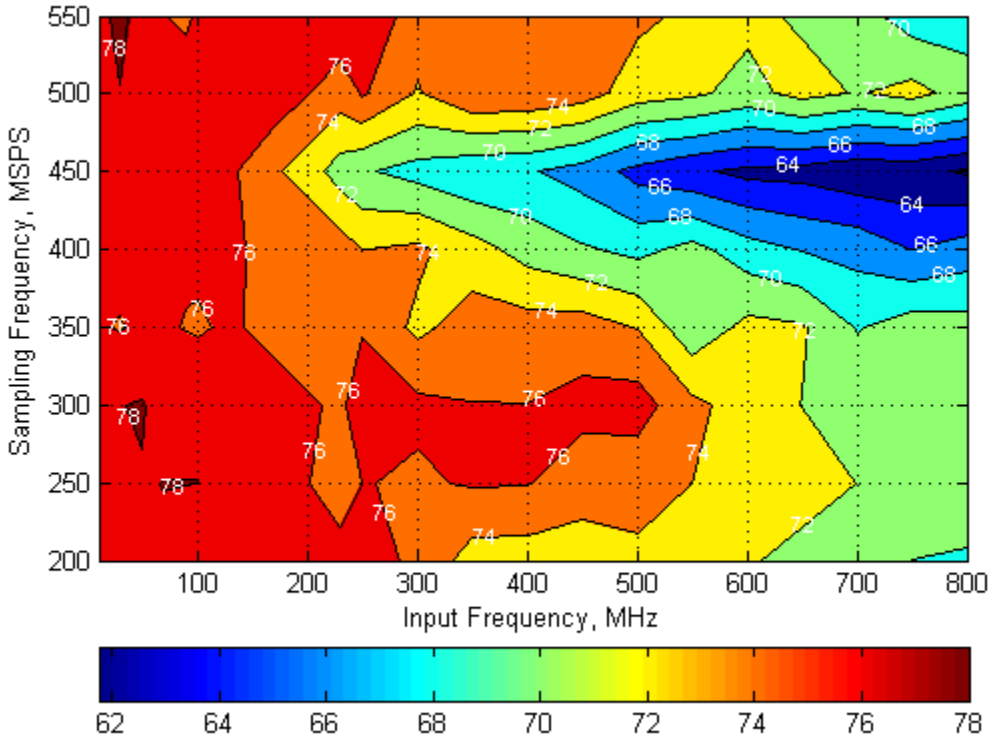


Figure 34.

TYPICAL CHARACTERISTICS (continued)

Typical values at TA = +25°C, full temperature range is T_{MIN} = -40°C to T_{MAX} = +85°C, ADC sampling rate = 500Msps, 50% clock duty cycle, AVDD33 = 3.3V, AVDDC/AVDD18/DVDD/DVDDLVDS/IOVDD = 1.8V, Vref = 1.25V, -1dBFS differential input, unless otherwise noted.

SNR Across Input and Sampling Frequencies (auto on)

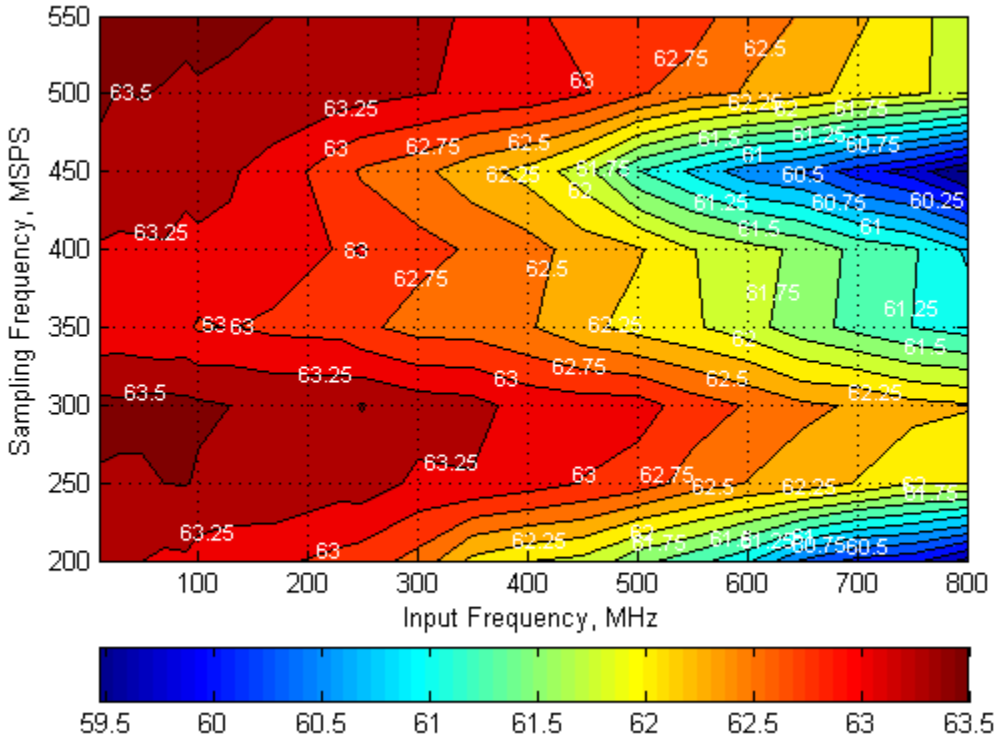


Figure 35.

TYPICAL CHARACTERISTICS (continued)

Typical values at TA = +25°C, full temperature range is T_{MIN} = -40°C to T_{MAX} = +85°C, ADC sampling rate = 500Msps, 50% clock duty cycle, AVDD33 = 3.3V, AVDDC/AVDD18/DVDD/DVDDLVDS/IOVDD = 1.8V, Vref = 1.25V, -1dBFS differential input, unless otherwise noted.

SNR Across Input and Sampling Frequencies (auto on)

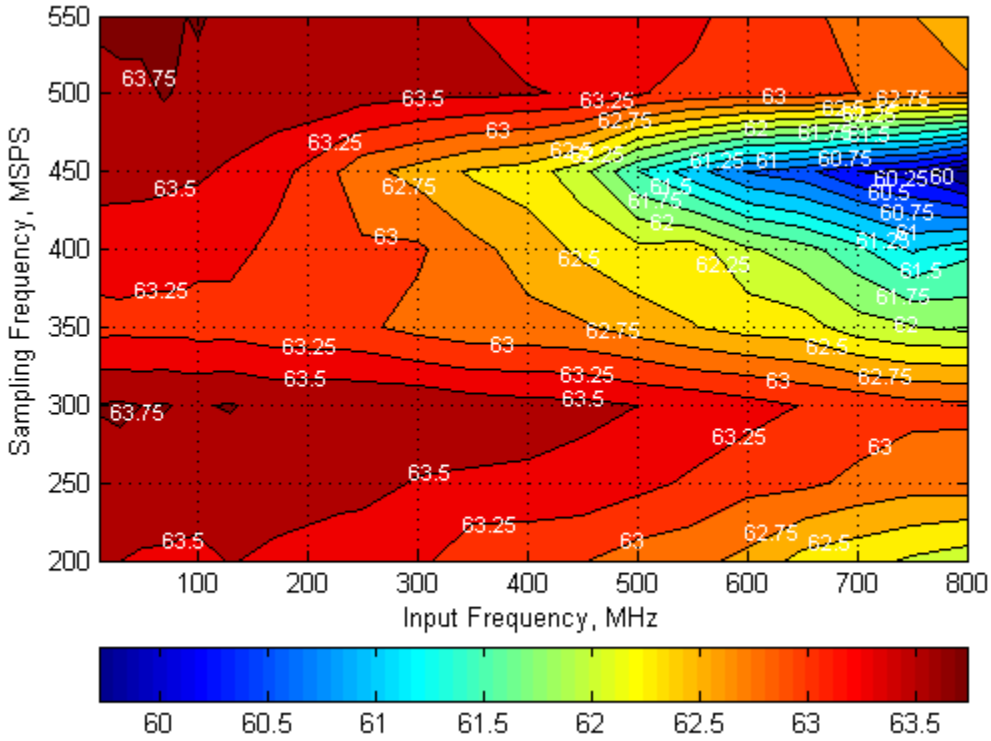


Figure 36.

FEATURES

POWER DOWN MODES

The ADS5407 can be configured via SPI write (address x37) to a stand-by, light or deep sleep power mode which is controlled by the ENABLE pin. The sleep modes are active when the ENABLE pin goes low. Different internal functions stay powered up which results in different power consumption and wake up time between the two sleep modes.

Sleep mode	Wake up time	Power Consumption Auto Correction Disabled	Power Consumption Auto Correction Enabled
Complete Shut Down	2.5 ms	7mW	7mW
Stand-by	100µs	7mW	7mW
Deep Sleep	20µs	264mW	371mW
Light Sleep	2µs	559mW	666mW

TEST PATTERN OUTPUT

The ADS5407 can be configured to output different test patterns that can be used to verify the digital interface is connected and working properly.

To enable the test pattern mode, the high performance mode 1 has to be disabled first via SPI register write. Then different test patterns can be selected by configuring registers x3C, x3D and x3E. All three registers must be configured for the test pattern to work properly.

First set HP1 = 0 (Addr 0x01, D01)

Register Address	All 0s	All 1s	Toggle (0xAAA => 0x555)	Toggle (0xFFF => 0x000)
0x3C	0x8000	0xBFFC	0x9554	0xBFFC
0x3D	0x0000	0x3FFC	0x2AA8	0x0000
0x3E	0x0000	0x3FFC	0x1554	0x3FFC

Register Address	Custom Pattern															
	D15	D14	D13	D12	D11	D10	D9	D8	D7	D6	D5	D4	D3	D2	D1	D0
x3C	1	0													0	0
x3D	0	0	D11	D10	D9	D8	D7	D6	D5	D4	D3	D2	D1	D0	0	0
x3E	0	0													0	0

For normal operation, set HP1 = 1 (Addr 0x01, D01) and 0x3C, 0x3D, 0x3E all to 0.

CLOCK INPUT

The ADS5407 clock input can be driven differentially with a sine wave, LVPECL or LVDS source with little or no difference in performance. The common mode voltage of the clock input is set to 0.9V using internal 2kΩ resistors. This allows for AC coupling of the clock inputs. The termination resistors should be placed as close as possible to the clock inputs in order to minimize signal reflections and jitter degradation.

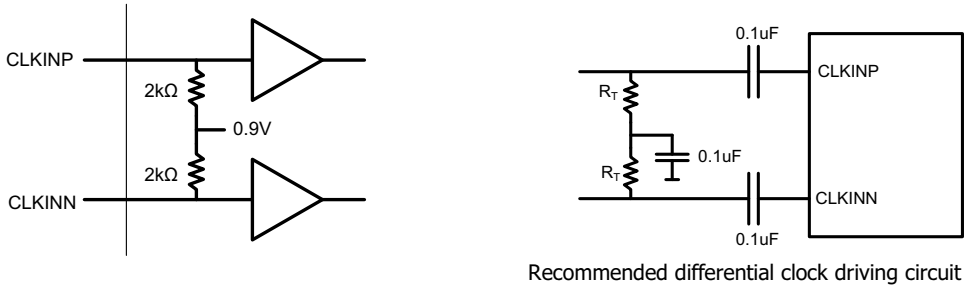


Figure 37. Recommended Differential Clock Driving Circuit

SNR AND CLOCK JITTER

The signal to noise ratio of the ADC is limited by three different factors: the quantization noise is typically not noticeable in pipeline converters and is 74dB for a 12bit ADC. The thermal noise limits the SNR at low input frequencies while the clock jitter sets the SNR for higher input frequencies.

$$SNR_{ADC}[dBc] = -20 \times \log \sqrt{\left(10 - \frac{SNR_{Quantization\_Noise}}{20}\right)^2 + \left(10 - \frac{SNR_{ThermalNoise}}{20}\right)^2 + \left(10 - \frac{SNR_{Jitter}}{20}\right)^2} \quad (1)$$

The SNR limitation due to sample clock jitter can be calculated as following:

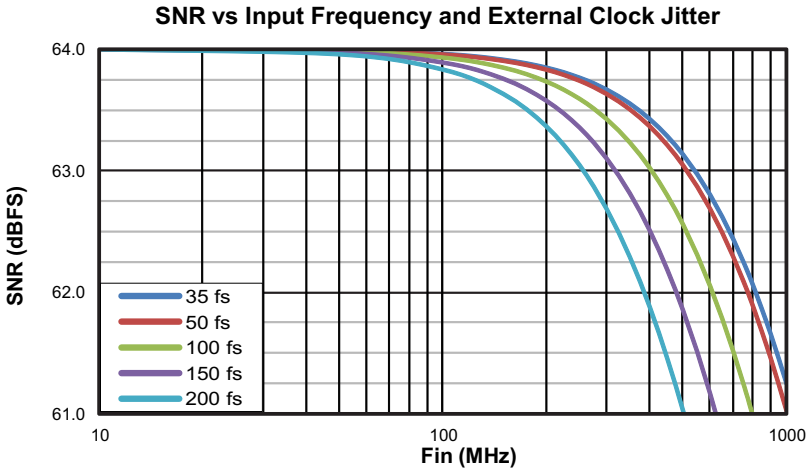
$$SNR_{Jitter}\ [dBc] = -20 \times \log(2\pi \times f_{IN} \times t_{Jitter}) \quad (2)$$

The total clock jitter (TJitter) has three components – the internal aperture jitter (100fs for ADS5407) which is set by the noise of the clock input buffer, the external clock jitter and the jitter from the analog input signal. It can be calculated as following:

$$T_{Jitter} = \sqrt{(T_{Jitter,Ext.Clock\_Input})^2 + (T_{Aperture\_ADC})^2} \quad (3)$$

External clock jitter can be minimized by using high quality clock sources and jitter cleaners as well as bandpass filters at the clock input while a faster clock slew rate improves the ADC aperture jitter.

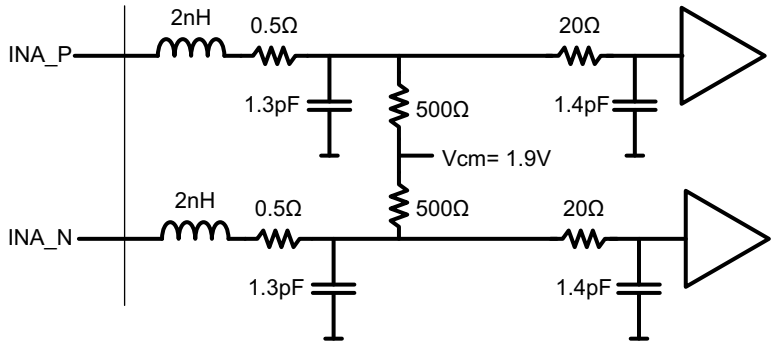
The ADS5407 has a thermal noise of 63.8 dBFS and internal aperture jitter of 100fs. The SNR depending on amount of external jitter for different input frequencies is shown in the following figure.



ANALOG INPUTS

The ADS5407 analog signal inputs are designed to be driven differentially. The analog input pins have internal analog buffers that drive the sampling circuit. As a result of the analog buffer, the input pins present a high impedance input across a very wide frequency range to the external driving source which enables great flexibility in the external analog filter design as well as excellent 50Ω matching for RF applications. The buffer also helps to isolate the external driving circuit from the internal switching currents of the sampling circuit which results in a more constant SFDR performance across input frequencies.

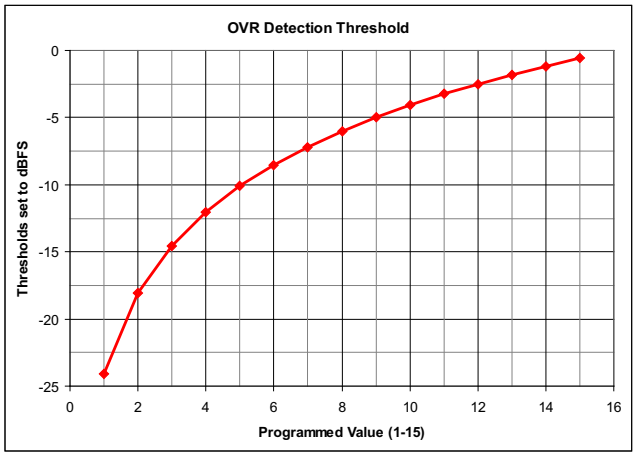
The common-mode voltage of the signal inputs is internally biased to 1.9V using 500Ω resistors which allows for AC coupling of the input drive network. Each input pin (INP, INM) must swing symmetrically between (VCM + 0.25V) and (VCM – 0.25V), resulting in a 1.0Vpp (default) differential input swing. The input sampling circuit has a 3dB bandwidth that extends up to 1.2GHz.



OVER-RANGE INDICATION

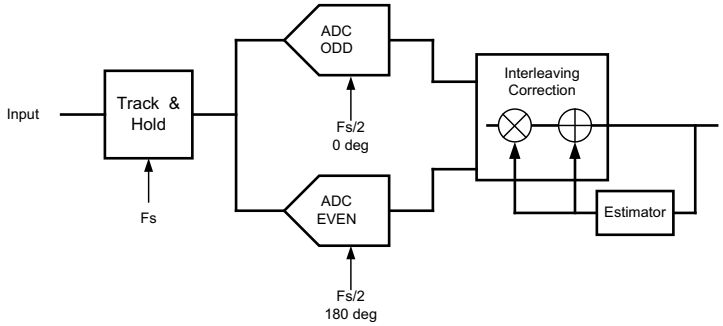
The ADS5407 provides a fast over-range indication on the OVRA/B pins. The fast OVR is triggered if the input voltage exceeds the programmable overrange threshold and it gets presented after just 12 clock cycles enabling a quicker reaction to an overrange event. The OVR threshold can be configured using SPI register writes.

The input voltage level at which the overload is detected is referred to as the threshold and is programmable using the Over-range threshold bits. The threshold at which fast OVR is triggered is (full-scale × [the decimal value of the FAST OVR THRESH bits] /16). After reset, the default value of the over-range threshold is set to 15 (decimal) which corresponds to a threshold of 0.56dB below full scale (20*log(15/16)).



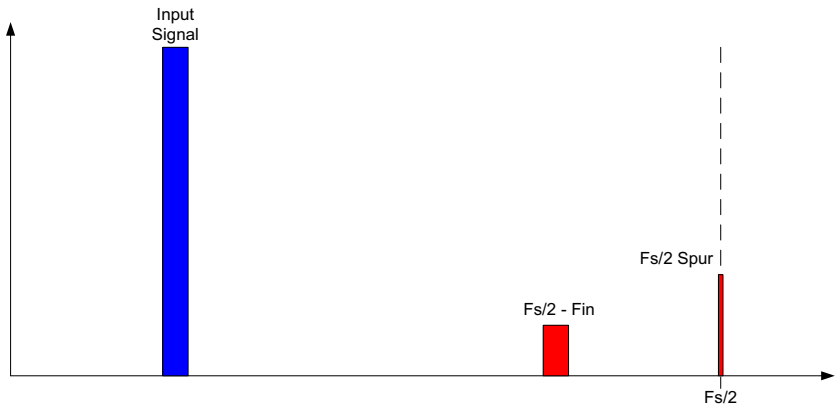
INTERLEAVING CORRECTION

Each of the two data converter channels consists of two interleaved ADCs each operating at half of the ADC sampling rate but 180º out of phase from each other. The front end track and hold circuitry is operating at the full ADC sampling rate which minimizes the timing mismatch between the two interleaved ADCs. In addition the ADS5407 is equipped with internal interleaving correction logic that can be enabled via SPI register write.



The interleaving operation creates 2 distinct and interleaving products:

- Fs/2 – Fin: this spur is created by gain timing mismatch between the ADCs. Since internally the front end track and hold is operated at the full sampling rate, this component is greatly improved and mostly dependent on gain mismatch.
- Fs/2 Spur: due to offset mismatch between ADCs



The auto correction loop can be enabled via SPI register write in address 0x01 and resetting the correction circuit in address 0x03 and 0x1A. . By default, it is disabled for lowest possible power consumption. The DC correction function can be enabled in 0x03 & 0x1A for chA and chB respectively. The default settings for the auto correction function should work for most applications. However please contact Texas Instruments if further fine tuning of the algorithm is required.

The auto correction function yields best performance for input frequencies below 250MHz.

DECIMATION FILTER

Each channel has a digital filter in the data path as shown in Figure 38. The filter can be programmed as a low-pass or a high-pass filter and the normalized frequency response of both filters is shown in Figure 39.

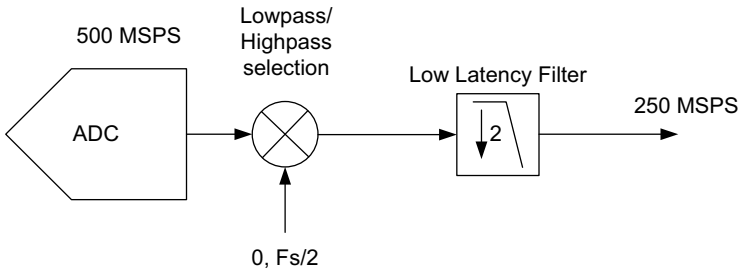


Figure 38.

The decimation filter response has a 0.1dB pass band ripple with approximately 41% pass-band bandwidth. The stop-band attenuation is approximately 40dB.

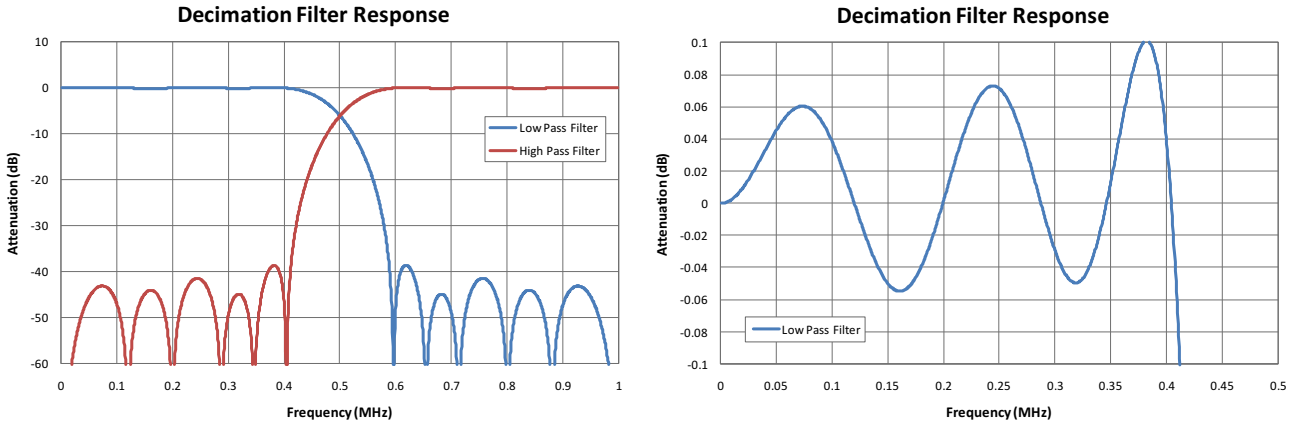
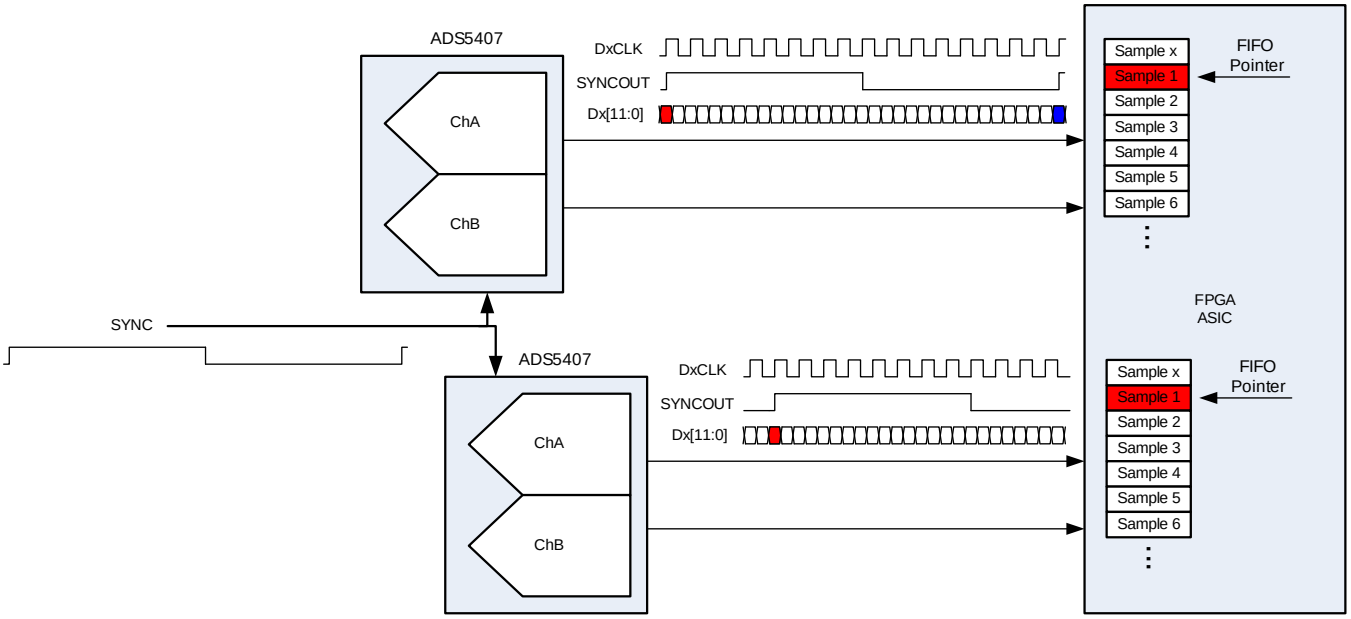


Figure 39.

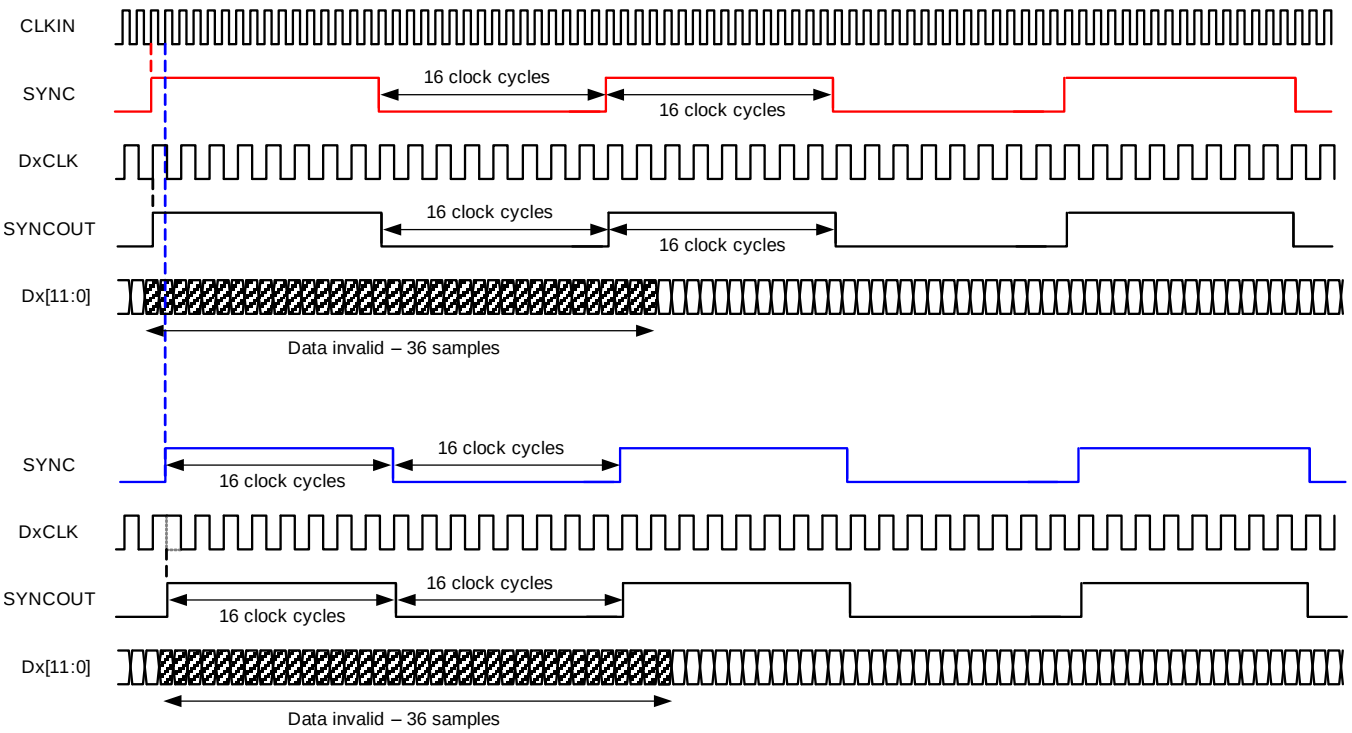
MULTI DEVICE SYNCHRONIZATION

The ADS5407 simplifies the synchronization of data from multiple ADCs in one common receiver. Upon receiving the initial SYNC input signal, the ADS5407 resets all the internal clocks and digital logic while also starting a SYNCOUT signal which operates on a 5bit counter (32 clock cycles). Therefore by providing a common SYNC signal to multiple ADCs their output data can be synchronized as the SYNCOUT signal marks a specific sample with the same latency in all ADCs. The SYNCOUT signal then can be used in the receiving device to synchronize the FIFO pointers across the different input data streams. Thus the output data of multiple ADCs can be aligned properly even if there are different trace lengths between the different ADCs.



The SYNC input signal should be a one time pulse to trigger the periodic 5-bit counter for SYNCOUT or a periodic signal repeating every 32 CLKIN clock cycles. It gets registered on the rising edge of the ADC input clock (CLKIN). Upon registering the initial rising edge of the SYNC signal, the internal clocks and logic get reset which results in invalid output data for 36 samples (1 complete sync cycle and 4 additional samples). The SYNCOUT signal starts with the next output clock (DACLK) rising edge and operates on a 5-bit counter. If a SYNCIN rising edge gets registered at a new position, the counter gets reset and SYNCOUT starts from the new position.

Since the ADS5407 output interface operates with a DDR clock, the synchronization can happen on the rising edge or falling edge sample. Synchronization on the falling edge sample will result in a half cycle clock stretch of DA/BCLK. For convenience the SYNCOUT signal is available on the ChA/B output LVDS bus. When using decimation the SYNCOUT signal still operates on 32 clock cycles of CLKIN but since the output data is decimated by 2, only the first 18 samples should be discarded.



PROGRAMMING INTERFACE

The serial interface (SIF) included in the ADS5407 is a simple 3 or 4 pin interface. In normal mode, 3 pins are used to communicate with the device. There is an enable (SDENB), a clock (SCLK) and a bi-directional IO port (SDIO). If the user would like to use the 4 pin interface one write must be implemented in the 3 pin mode to enable 4 pin communications. In this mode, the SDO pin becomes the dedicated output. The serial interface has an 8-bit address word and a 16-bit data word. The first rising edge of SCLK after SDENB goes low will latch the read/write bit. If a high is registered then a read is requested, if it is low then a write is requested. SDENB must be brought high again before another transfer can be requested. The signal diagram is shown below:

Device Initialization

After power up, it is recommended to initialize the device through a hardware reset by applying a logic low pulse on the SRESETb pin (of width greater than 20ns), as shown in Figure 40. This resets all internal digital blocks (including SPI registers) to their default condition.

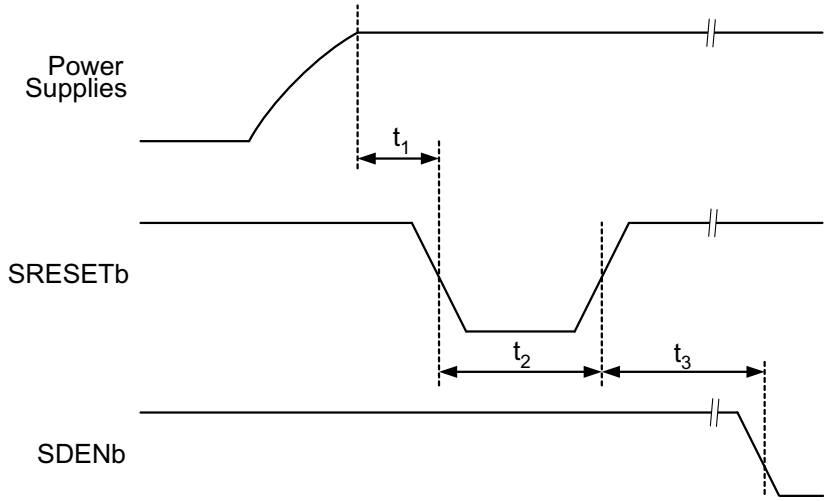


Figure 40. Device Initialization Timing Diagram

Table 1. Reset Timing

PARAMETER		CONDITIONS	MIN	TYP	MAX	UNIT
t_1	Power-on delay	Delay from power up to active low RESET pulse	3			ms
t_2	Reset pulse width	Active low RESET pulse width	20			ns
t_3	Register write delay	Delay from RESET disable to SDENb active	100			ns

Recommended Device Initialization Sequence:

1. Power up
2. Reset ADS5407 using hardware reset.
3. Apply clock and input signal.
4. Set register 0x01 bit D15 to ”1” (ChA Corr EN) and bit D9 to ”1” (ChB Corr EN) to enable gain/offset correction circuit and other desired registers.
5. Set register 0x03 and 0x1A bit D14 to “1” (Start Auto Corr ChA/B). This clears and resets the accumulator values in the DC and gain correction loop.
6. Set register 0x03 and 0x1A bit D14 to “0” (Start Auto Corr ChA/B). This starts the DC and gain auto-correction loop.

Serial Register Write

The internal register of the ADS5407 can be programmed following these steps:

1. Drive SDENB pin low
2. Set the R/W bit to ‘0’ (bit A7 of the 8 bit address)

3. Initiate a serial interface cycle specifying the address of the register (A6 to A0) whose content has to be written
4. Write 16bit data which is latched on the rising edge of SCLK

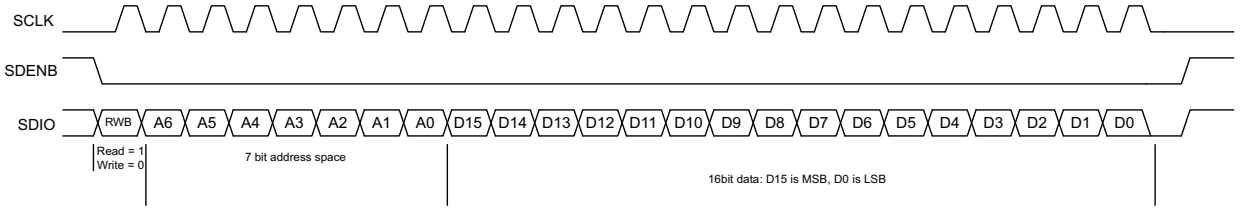


Figure 41. Serial Register Write Timing Diagram

PARAMETER		MIN	TYP(1)	MAX	UNIT
f_{SCLK}	SCLK frequency (equal to 1/tSCLK)	>DC		20	MHz
t_{SLOADS}	SDENB to SCLK setup time	25			ns
t_{SLOADH}	SCLK to SDENB hold time	25			ns
t_{DSU}	SDIO setup time	25			ns
t_{DH}	SDIO hold time	25			ns

(1) Typical values at +25°C; minimum and maximum values across the full temperature range: TMIN = –40°C to TMAX = +85°C, AVDD3V = 3.3V, AVDD, DRVDD = 1.9V, unless otherwise noted.

Serial Register Readout

The device includes a mode where the contents of the internal registers can be read back using the SDO/SDIO pins. This read-back mode may be useful as a diagnostic check to verify the serial interface communication between the external controller and the ADC.

1. Drive SDENB pin low
2. Set the RW bit (A7) to '1'. This setting disables any further writes to the registers
3. Initiate a serial interface cycle specifying the address of the register (A6 to A0) whose content has to be read.
4. The device outputs the contents (D15 to D0) of the selected register on the SDO/SDIO pin
5. The external controller can latch the contents at the SCLK rising edge.
6. To enable register writes, reset the RW register bit to '0'.

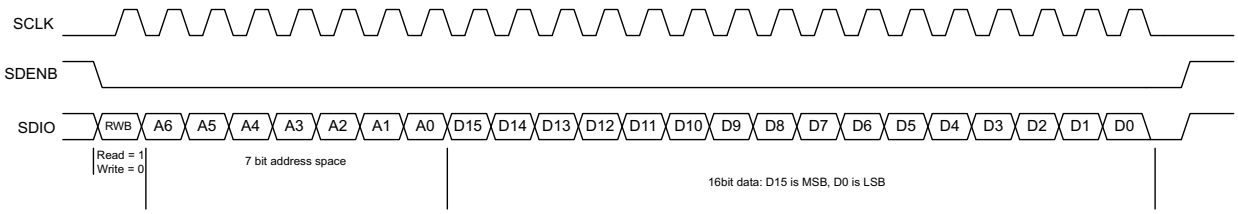


Figure 42. Serial Register Read Timing Diagram

SERIAL REGISTER MAP(2)

(2) Multiple functions in a register can be programmed in a single write operation.

Register Address	Register Data															
A7–A0 IN HEX	D15	D14	D13	D12	D11	D10	D9	D8	D7	D6	D5	D4	D3	D2	D1	D0
0	3/4 Wire SPI	Decimation Filter EN	0	ChA High/ Low Pass	0	0	ChB High/ Low Pass	0	0	0	0	0	0	0	0	0
1	ChA Corr EN	0	0	0	0	0	ChB Corr EN	0	0	0	0	0	Data Format	0	Hp Mode1	0
2	0	0	0	0	0	Over-range threshold				0	0	0	0	0	0	0
3	0	Start Auto Corr ChA	0	0	1	0	1	1	0	0	0	1	1	0	0	0
E	Sync Select														0	0
F	Sync Select				0	0	0	0	0	VREF Set			0	0	0	0
1A	0	Start Auto Corr ChB	0	0	1	0	1	1	0	0	0	1	1	0	0	0
2B	0	0	0	0	0	0	0	Temp Sensor								
2C	Reset															
37	Sleep Modes						0	0	0	0	0	0	0	0	0	0
38	HP Mode2									BIAS EN	SYNC EN	LP Mode 1	1	1	1	1
3A	LVDS Current Strength		LVDS SW		Internal LVDS Termination		0	0	0	0	0	DACLK EN	DBCLK EN	0	OVRA EN	OVRB EN
66	LVDS Output Bus A EN															
67	LVDS Output Bus B EN															

DESCRIPTION OF SERIAL INTERFACE REGISTERS

Register Address	Register Data															
A7-A0 in hex	D15	D14	D13	D12	D11	D10	D9	D8	D7	D6	D5	D4	D3	D2	D1	D0
0	3/4 Wire SPI	Decimation Filter EN	0	ChA High/ Low Pass	0	0	ChB High/ Low Pass	0	0	0	0	0	0	0r	0	0

D15 **3/4 Wire SPI** Enables 4-bit serial interface when set
Default 0

0 3 wire SPI is used with SDIO pin operating as bi-directional I/O port

1 4 wire SPI is used with SDIO pin operating as data input and SDO pin as data output port.

D14 **Decimation Filter EN** 2x decimation filter is enabled when bit is set
Default 0

0 Normal operation with data output at full sampling rate

1 2x decimation filter enabled

D12 **ChA High/Low Pass** (Decimation filter must be enabled first: set bit D14)
Default 0

0 Low Pass

1 High Pass

D9 **ChB High/Low Pass** (Decimation filter must be enabled first: set bit D14)
Default 0

0 Low Pass

1 High Pass

Register Address	Register Data															
A7-A0 in hex	D15	D14	D13	D12	D11	D10	D9	D8	D7	D6	D5	D4	D3	D2	D1	D0
1	ChA Corr EN	0	0	0	0	0	ChB Corr EN	0	0	0	0	0	Data Format	0	HP Mode1	0

D15 **ChA Corr EN (should be enabled for maximum performance)**
Default 0

0 auto correction disabled

1 auto correction enabled

D9 **ChB Corr EN (should be enabled for maximum performance)**
Default 0

0 auto correction disabled

1 auto correction enabled

D3 **Data Format**
Default 0

0 Two's complement

1 Offset Binary

D1 **HP Mode 1**
Default 0

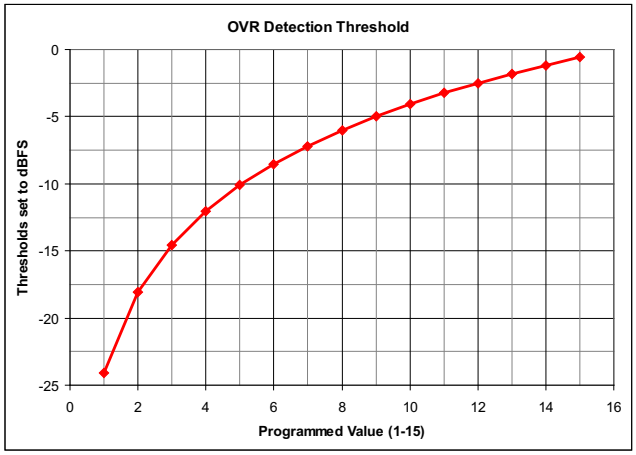
1 Must be set to 1 for optimum performance

Register Address	Register Data															
A7-A0 in hex	D15	D14	D13	D12	D11	D10	D9	D8	D7	D6	D5	D4	D3	D2	D1	D0
2	0	0	0	0	0	Over-range threshold				0	0	0	0	0	0	0

D10-D7 **Over-range threshold** The over-range detection is triggered 20 output clock cycles after the overload condition occurs. The threshold at which the OVR is triggered = 1.1V x [decimal value of <Over-range threshold>]/16. After power up or reset, the default value is 15 (decimal) which corresponds to a OVR threshold of 0.56dB below fullscale (20 x log(15/16)).

This OVR threshold is applicable to both channels.

Default 1111



Register Address	Register Data															
A7-A0 in hex	D15	D14	D13	D12	D11	D10	D9	D8	D7	D6	D5	D4	D3	D2	D1	D0
3	0	DC Offset Coff ChA	0	0	1	0	1	1	0	0	0	1	1	0	0	0

D14	**DC Offset Corr ChA** Default 1	Starts DC offset correction loop for ChA
0	Starts offset correction loop for ChA	
1	DC offset correction loop is cleared	
D11, 9, 8, 4, 3	Must be set to 1 for maximum performance Default 1	

Register Address	Register Data															
A7-A0 in hex	D15	D14	D13	D12	D11	D10	D9	D8	D7	D6	D5	D4	D3	D2	D1	D0
E	Sync Select														0	0

D15-D2 **Sync Select** Sync selection for the clock generator block (also need to see address 0x0F)
Default 1010 1010 1010 10

0000 0000 0000 00 Sync is disabled

0101 0101 0101 01 Sync is set to one shot (one time synchronization only)

1010 1010 1010 10 Sync is derived from SYNC input pins

1111 1111 1111 11 not supported

Register Address	Register Data															
A7-A0 in hex	D15	D14	D13	D12	D11	D10	D9	D8	D7	D6	D5	D4	D3	D2	D1	D0
F	Sync Select				0	0	0	0	0	VREF Sel			0	0	0	0

D15-D12 **Sync Select** Sync selection for the clock generator block
Default 1010

0000 Sync is disabled

0101 Sync is set to one shot (one time synchronization only)

1010 Sync is derived from SYNC input pins

1111 not supported

D6-D4 **VREF SEL** Internal voltage reference selection
Default 000

000 1.0V

001 1.25V

010 0.9V

011 0.8V

100 1.15V

Others external reference

Register Address	Register Data															
A7-A0 in hex	D15	D14	D13	D12	D11	D10	D9	D8	D7	D6	D5	D4	D3	D2	D1	D0
1A	0	Start Auto Corr ChB	0	0	1	0	1	1	0	0	0	1	1	0	0	0

D14 **Start Auto Corr ChB** Starts DC offset and Gain correction loop for ChB
Default 1

0 Starts the DC offset and Gain correction loops for ChB

1 Clears DC offset correction value to 0 and Gain correction value to 1

D11, 9, 8, 4, 3 Must be set to 1 for maximum performance
Default 1

Register Address	Register Data															
A7-A0 in hex	D15	D14	D13	D12	D11	D10	D9	D8	D7	D6	D5	D4	D3	D2	D1	D0
2B	0	0	0	0	0	0	0	Temp Sensor								

D8-D0 **Temp Sensor** Internal temperature sensor value – read only

Register Address	Register Data															
A7-A0 in hex	D15	D14	D13	D12	D11	D10	D9	D8	D7	D6	D5	D4	D3	D2	D1	D0
2C	Reset															

D15-D0 **Reset** Default 0000 This is a software reset to reset all SPI registers to their default value. Self clears to 0.

1101001011110000 Perform software reset

Register Address	Register Data															
A7-A0 in hex	D15	D14	D13	D12	D11	D10	D9	D8	D7	D6	D5	D4	D3	D2	D1	D0
37	Sleep Modes						0	0	0	0	0	0	0	0	0	0

D15-D14 **Sleep Modes** Default 00 Sleep mode selection which is controlled by the ENABLE pin. Sleep modes are active when ENABLE pin goes low.

000000	Complete shut down	Wake up time 2.5 ms
100000	Stand-by mode	Wake up time 100 µs
110000	Deep sleep mode	Wake up time 20 µs
110101	Light sleep mode	Wake up time 2 µs

Register Address	Register Data															
A7-A0 in hex	D15	D14	D13	D12	D11	D10	D9	D8	D7	D6	D5	D4	D3	D2	D1	D0
38	HP Mode 2									Bias EN	SYNC EN	LP Mode 1	1	1	1	1

D15-D7 **HP Mode 2**
Default 111111111

1 Set to 1 for normal operation

D6 **BIAS EN** Enables internal fuse bias voltages – can be disabled after power up to save power.
Default 1

0 Internal bias powered down

1 Internal bias enabled

D5 **SYNC EN** Enables the SYNC input buffer.
Default 1

0 SYNC input buffer disabled

1 SYNC input bffer enabled

D4 **LP Mode 1** Low power mode 1 to disable unused internal input buffer
Default 1

0 Internal input buffer disabled

1 Internal input buffer enabled

D3-D0 Reads back 1

Register Address	Register Data															
A7-A0 in hex	D15	D14	D13	D12	D11	D10	D9	D8	D7	D6	D5	D4	D3	D2	D1	D0
3A	LVDS Current Strength			LVDS SW		Internal LVDS Termination		0	0	0	0	DACLK EN	DBCLK EN	0	OVRA EN	OVRB EN

D15-D13 **LVDS Current Strength** LVDS output current strength.
Default 000

000	2 mA	100	3 mA
001	2.25 mA	101	3.25 mA
010	2.5 mA	110	3.5 mA
011	2.75 mA	111	3.75 mA

D12-D11 **LVDS SW** LVDS driver internal switch setting – correct range must be set for setting in D15-D13
Default 01

01 2 mA to 2.75 mA
11 3mA to 3.75mA

D10-D9 **Internal LVDS Termination** Internal termination
Default 00

00 2 kΩ
01 200 Ω
10 200 Ω
11 100 Ω

D4 **DACLK EN** Enable DACLK output buffer
Default 1

0 DACLK output buffer powered down
1 DACLK output buffer enabled

D3 **DBCLK EN** Enable DBCLK output buffer
Default 1

0 DBCLK output buffer powered down
1 DBCLK output buffer enabled

D1 **OVRA EN** Enable OVRA output buffer
Default 1

0 OVRA output buffer powered down
1 OVRA output buffer enabled

D0 **OVRB EN** Enable OVRB output buffer
Default 1

0 OVRB output buffer powered down
1 OVRB output buffer enabled

Register Address	Register Data															
A7-A0 in hex	D15	D14	D13	D12	D11	D10	D9	D8	D7	D6	D5	D4	D3	D2	D1	D0
66	LVDS Output Bus A EN															

D15-D0	**LVDS Output Bus A EN** Default FFFF	Individual LVDS output pin power down for channel A
0	Output is powered down	
1	Output is enabled	
D15	Pins N7, P7 (no connect pins) which are not used and should be powered down for power savings	
D14	Pins N6, P6 (no connect pins) which are not used and should be powered down for power savings.	
D13	SYNCOUTP/N (pins N5, P5)	
D12	Pins N4, P4 (no connect pins) which are not used and should be powered down for power savings	
D11-D0	corresponds to DA11-DA0	

Register Address	Register Data															
A7-A0 in hex	D15	D14	D13	D12	D11	D10	D9	D8	D7	D6	D5	D4	D3	D2	D1	D0
67	LVDS Output Bus B EN															

D15-D0	**LVDS Output Bus B EN** Default FFFF	Individual LVDS output pin power down for channel B
0	Output is powered down	
1	Output is enabled	
D15	Pins G3, G4 (no connect pins) which are not used and should be powered down for power savings	
D14	Pins F3, F4 (no connect pins) which are not used and should be powered down for power savings.	
D13	SYNCOUTP/N (pins F1, F2)	
D12	Pins E3, E4 (no connect pins) which are not used and should be powered down for power savings	
D11-D0	corresponds to DB11-DB0	

REVISION HISTORY

Changes from Revision A (August 2013) to Revision B **Page**

- Changed package from QFN to nFBGA in THERMAL INFORMATION 5
- Deleted text from last paragraph in INTERLEAVING CORRECTION section 23
- Changed second paragraph in MULTI DEVICE SYNCHRONIZATION section 25
- Deleted Register Initialization section and added Device Initialization section 27
- Changed Register Address E BitsD1 and D0 to 0 in SERIAL REGISTER MAP 30
- Changed Register Address 38 Bits D3 to D0 from 0 to 1 in SERIAL REGISTER MAP 30
- Changed Register Address E Bit D1 and D0 to 0 33
- Changed Register Address 38 Bits D3 to D0 from 0 to 1 and add D3 to D0 Read back 1 35
- Changed Register Address 66 D15-D10 to D15-D0 and DA11-D0 to DA11-DA0 37
- Changed Register Address 67 D15-D10 to D15-D0 37

Changes from Original (March 2013) to Revision A **Page**

- Changed D13 in Register 66 From: SYNCOUTP/N (pins F1, F2) To: SYNCOUTP/N (pins N5, P5) 37
- Changed D12 in Register 66 From: "Pins E3, E4..." To: "Pins N4, P4..." 37
- Changed D11-D10 - corresponds to DB11-DB0 in Register 66 To: D11-D0 -corresponds to DA11-D0 37
- Changed D11-D10 - corresponds to DB11-DB0 in Register 67 To: D11-D0 -corresponds to DB11-DB0 37

PACKAGING INFORMATION

Orderable part number	Status (1)	Material type (2)	Package | Pins	Package qty | Carrier	RoHS (3)	Lead finish/ Ball material (4)	MSL rating/ Peak reflow (5)	Op temp (°C)	Part marking (6)
ADS5407IZAY	Active	Production	NFBGA (ZAY) | 196	160 | JEDEC TRAY (5+1)	Yes	SNAGCU	Level-3-260C-168 HR	-40 to 85	ADS5407I
ADS5407IZAYR	Active	Production	NFBGA (ZAY) | 196	1000 | LARGE T&R	Yes	SNAGCU	Level-3-260C-168 HR	-40 to 85	ADS5407I

(1) **Status:** For more details on status, see our product life cycle.

(2) **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

(3) **RoHS values:** Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

(4) **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

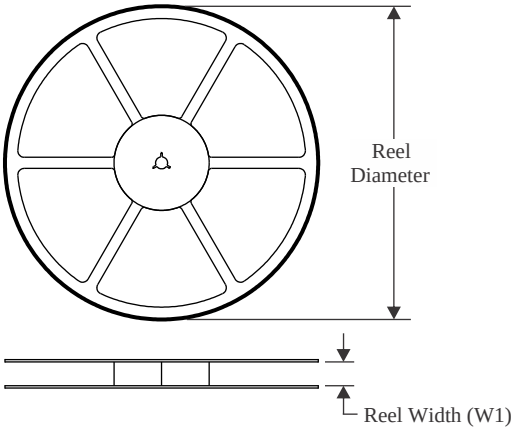
(5) **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

(6) **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

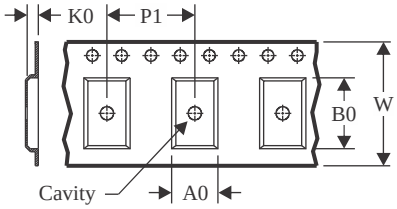
Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

TAPE AND REEL INFORMATION

REEL DIMENSIONS

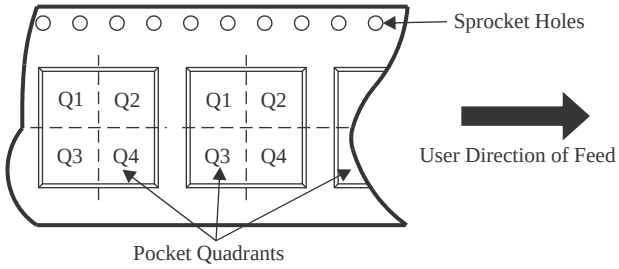


TAPE DIMENSIONS



A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

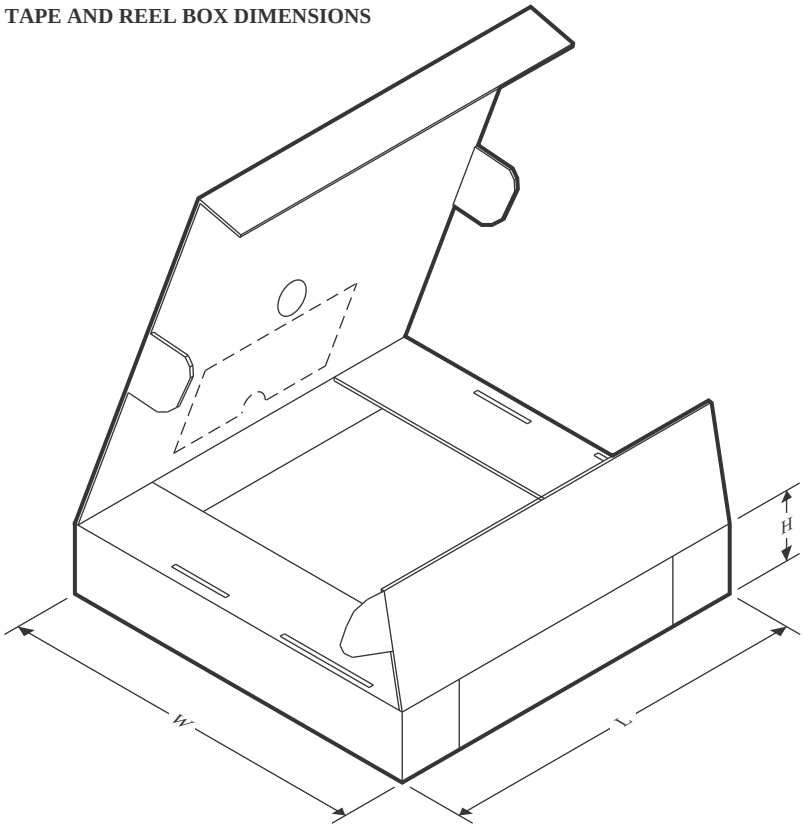
QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
ADS5407IZAYR	NFBGA	ZAY	196	1000	330.0	24.4	12.3	12.3	2.3	16.0	24.0	Q1

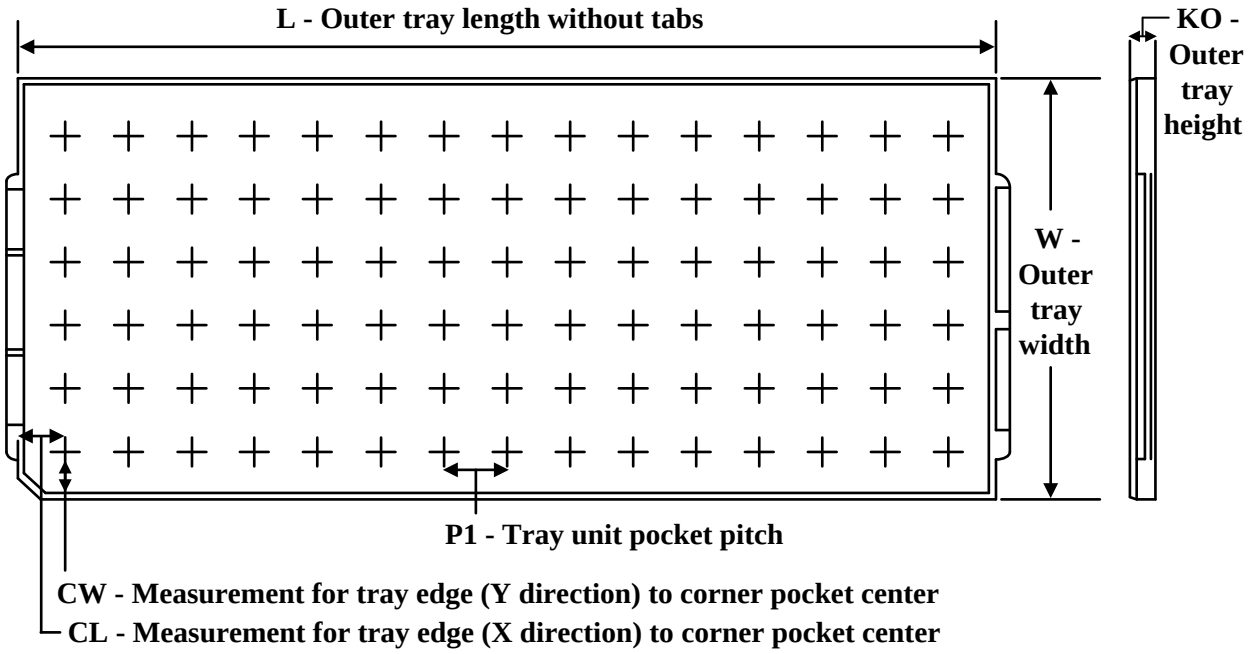
TAPE AND REEL BOX DIMENSIONS



*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
ADS5407IZAYR	NFBGA	ZAY	196	1000	350.0	350.0	43.0

TRAY



Chamfer on Tray corner indicates Pin 1 orientation of packed units.

*All dimensions are nominal

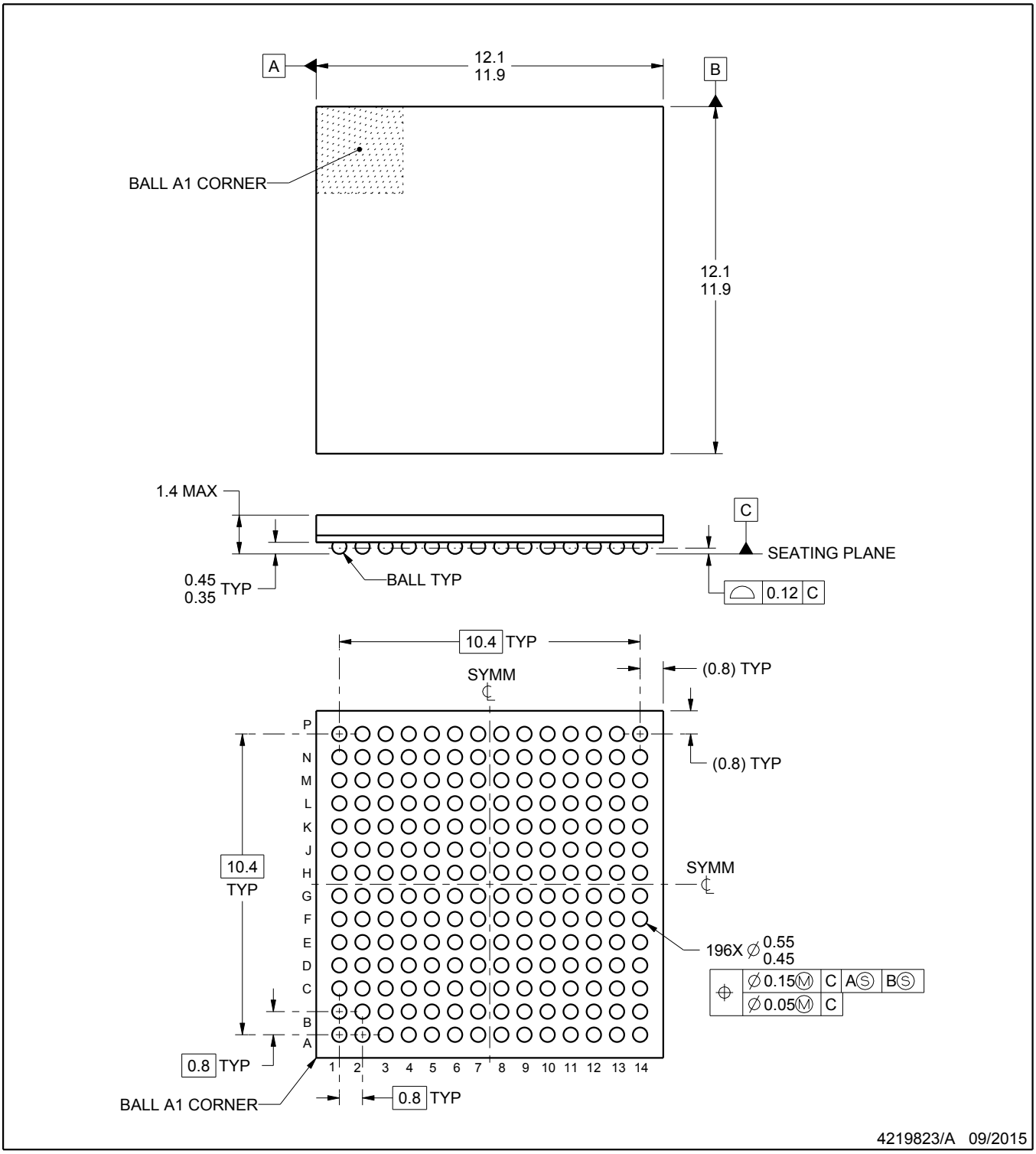
Device	Package Name	Package Type	Pins	SPQ	Unit array matrix	Max temperature (°C)	L (mm)	W (mm)	K0 (µm)	P1 (mm)	CL (mm)	CW (mm)
ADS5407IZAY	ZAY	NFBGA	196	160	8 x 20	150	315	135.9	7620	15.4	11.2	19.65

PACKAGE OUTLINE

ZAY0196A

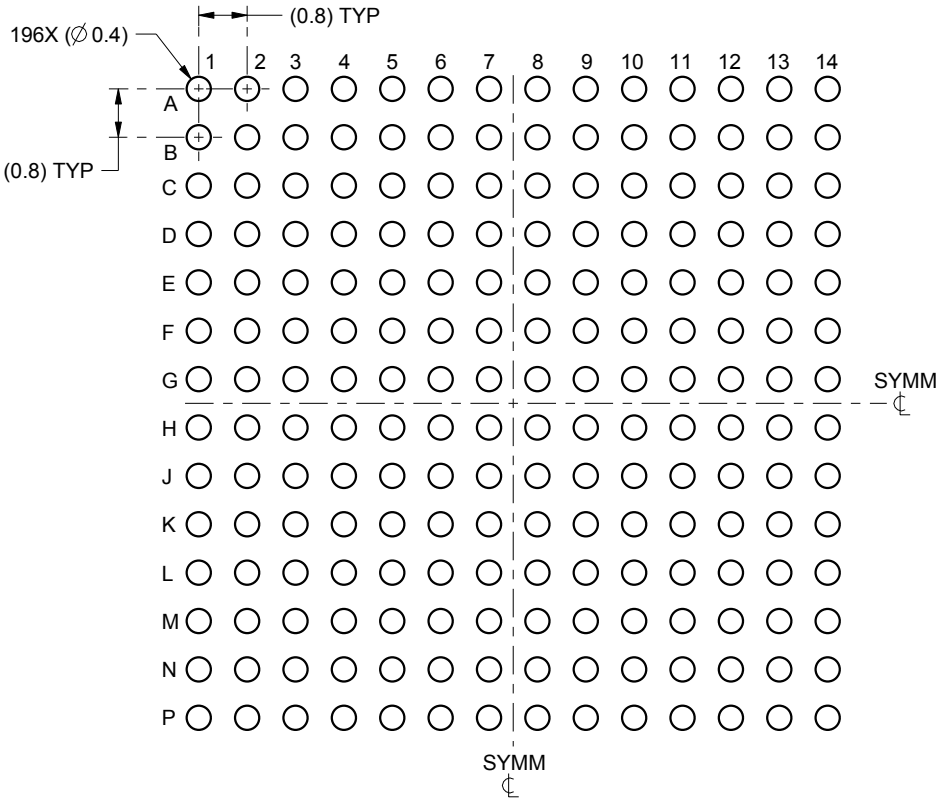
NFBGA - 1.4 mm max height

PLASTIC BALL GRID ARRAY

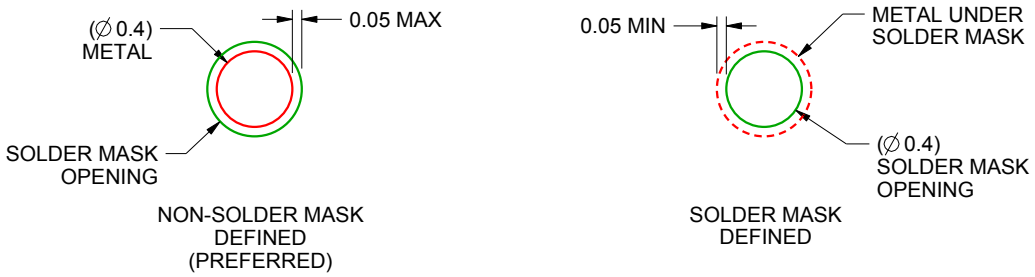


NOTES:

1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.



LAND PATTERN EXAMPLE
SCALE:8X



SOLDER MASK DETAILS
NOT TO SCALE

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NOTES: (continued)

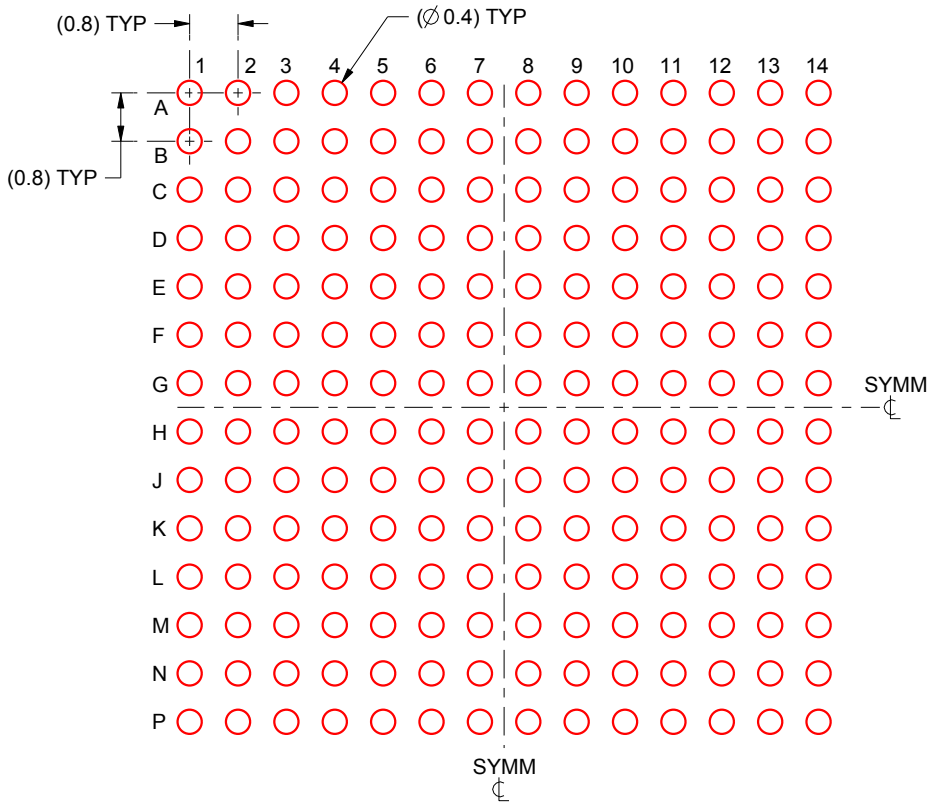
3. Final dimensions may vary due to manufacturing tolerance considerations and also routing constraints. For information, see Texas Instruments literature number SPRAA99 (www.ti.com/lit/spraa99).

EXAMPLE STENCIL DESIGN

ZAY0196A

NFBGA - 1.4 mm max height

PLASTIC BALL GRID ARRAY



SOLDER PASTE EXAMPLE
BASED ON 0.15 mm THICK STENCIL
SCALE:8X

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NOTES: (continued)

4. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release.

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